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(54) **AUTOMATIC CIRCUIT AND METHOD FOR TEMPERATURE COMPENSATION OF OSCILLATOR FREQUENCY VARIATION OVER TEMPERATURE FOR A REAL TIME CLOCK CHIP**

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H03L 1/00 (2006.01)

(52) **U.S. Cl.** **368/202; 331/176**

(58) **Field of Classification Search** **368/10, 368/156, 159, 200-202; 331/66, 176, 158**

See application file for complete search history.

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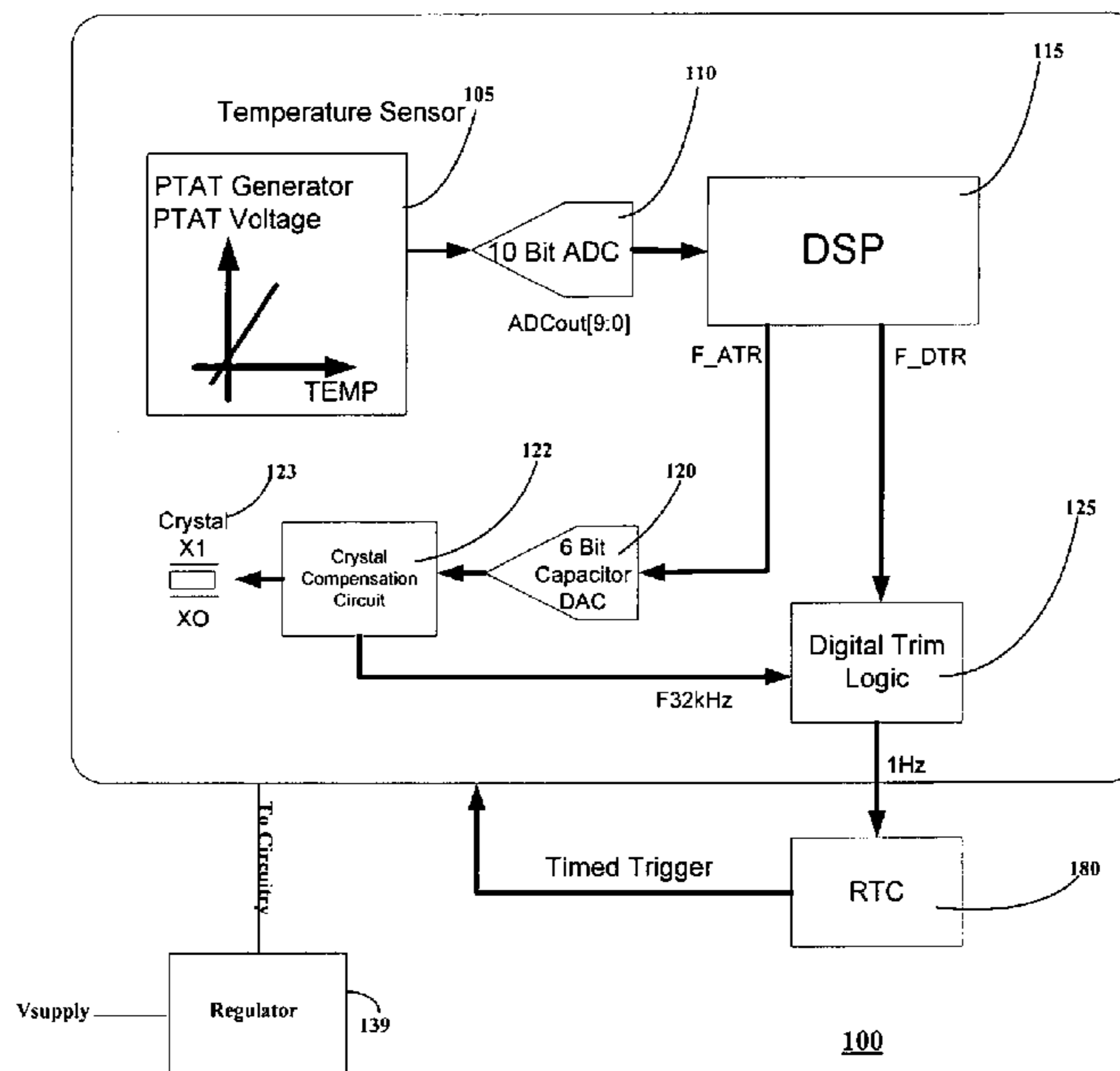
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(57) **ABSTRACT**

An automatic temperature compensated real-time clock (RTC) chip includes a clock portion having a crystal oscillator block including crystal compensation circuitry adapted to be coupled to a crystal. The crystal compensation circuitry includes a non-linear capacitor DAC including a plurality of load capacitors, wherein the load capacitors have respective switches which switch respective ones of the load capacitors to change a parallel resonance frequency (fp) generated by the oscillator block. The capacitor DAC is arranged so that Analog Trimming (ATR) bits received cause an arrangement of the switches to provide a non-linear change in overall load capacitance to result in a linear relationship between fp and the ATR bits. A temperature sensor block is coupled to the crystal for measuring a temperature of at least the crystal. An A/D converter is coupled to the temperature sensor for outputting a digital temperature signal representative of the temperature of the crystal. A DSP engine receives the digital temperature signal and calculates frequency correction needed to correct for frequency inaccuracy and determines a bit sequence including the ATR bits appropriate to achieve the frequency correction.

35 Claims, 18 Drawing Sheets



Temperature Drift: PPM Delta = - $\text{Alpha} * (T - 25)^2$

Typical $\text{Alpha} = .034 \text{ppm/C}^2$ Parabolic Temp Characteristics.

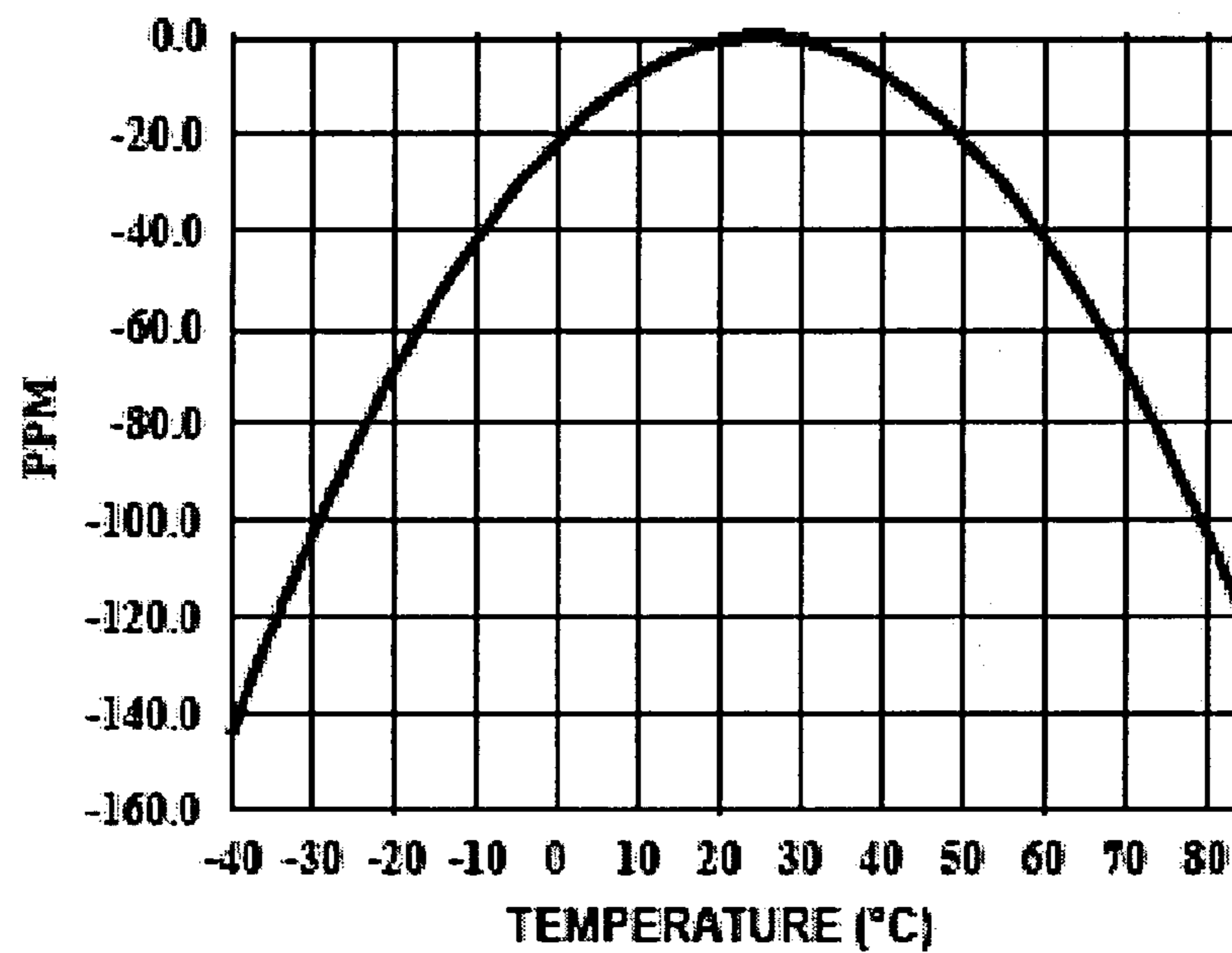
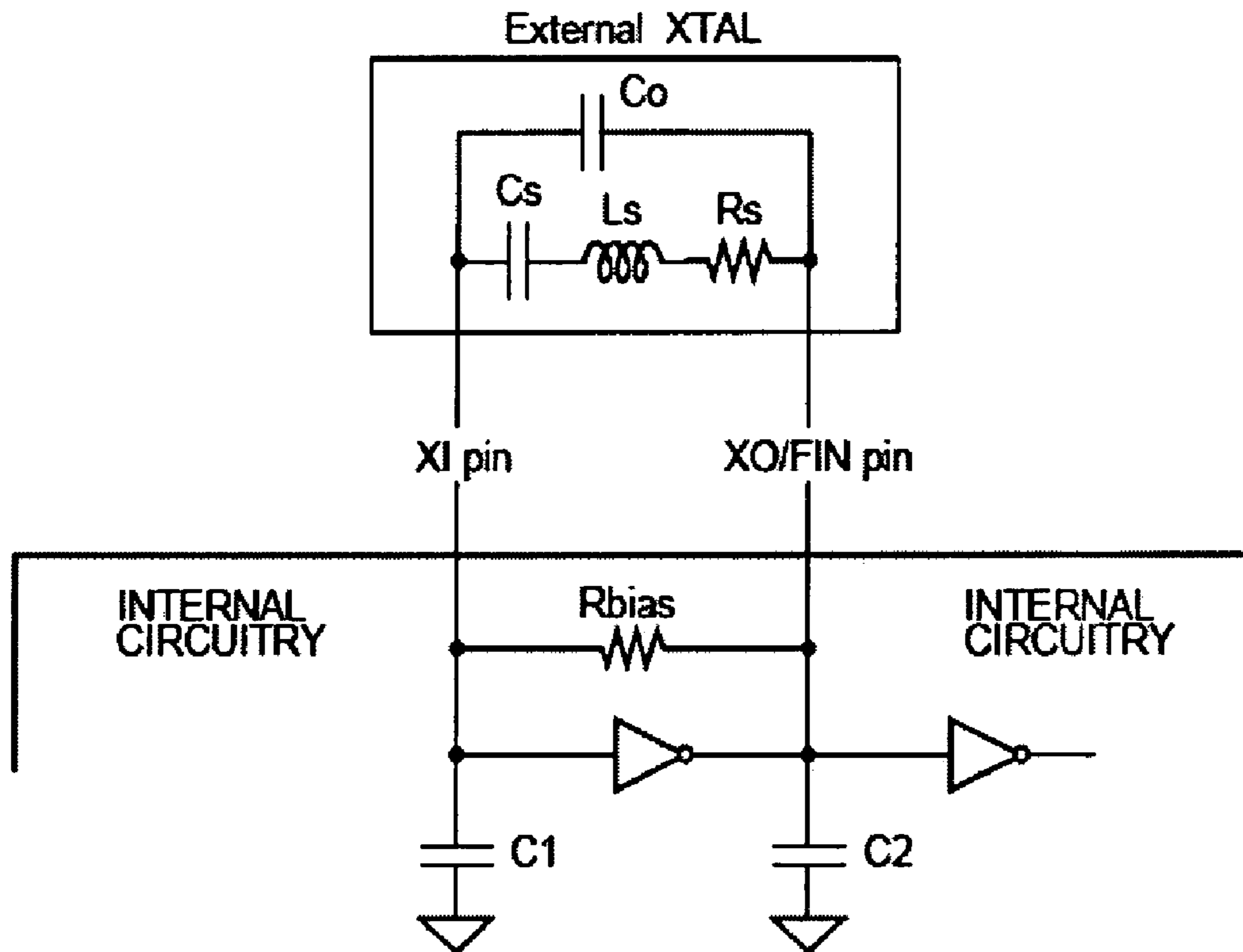
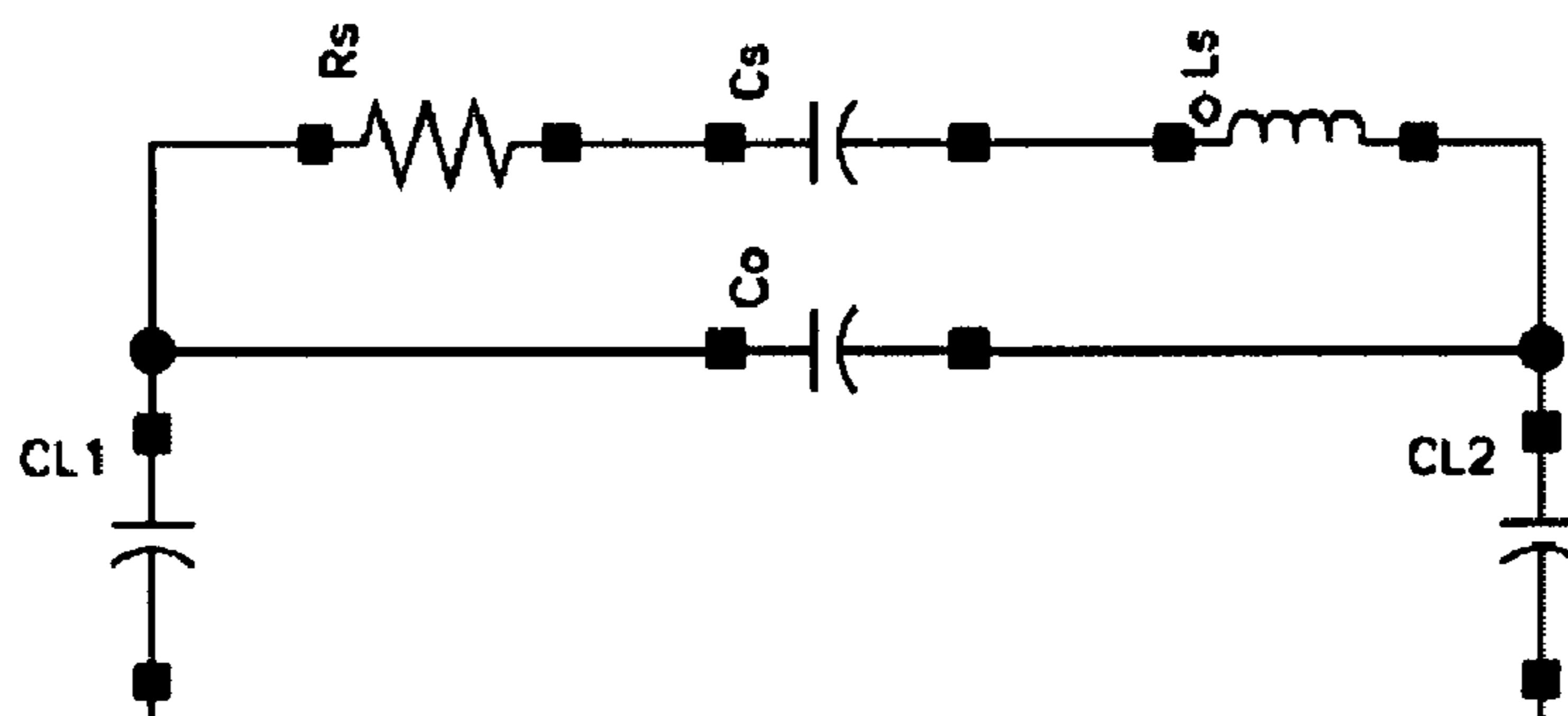


FIG. 1: RTC CRYSTAL TEMPERATURE DRIFT
(PRIOR ART)



**FIG. 2(a): PIERCE OSCILLATOR
(PRIOR ART)**

Crystal Oscillator ATR



$$f_s = \frac{1}{2\pi \sqrt{L_s C_s}}$$

$$f_p = f_s \left[1 + \frac{C_s}{2(C_L + C_o)} \right]$$

$$C_L = \frac{C_{L1} * C_{L2}}{C_{L1} + C_{L2}}$$

The frequency can be varied by changing CL.

FIG. 2(b)

(PRIOR ART)

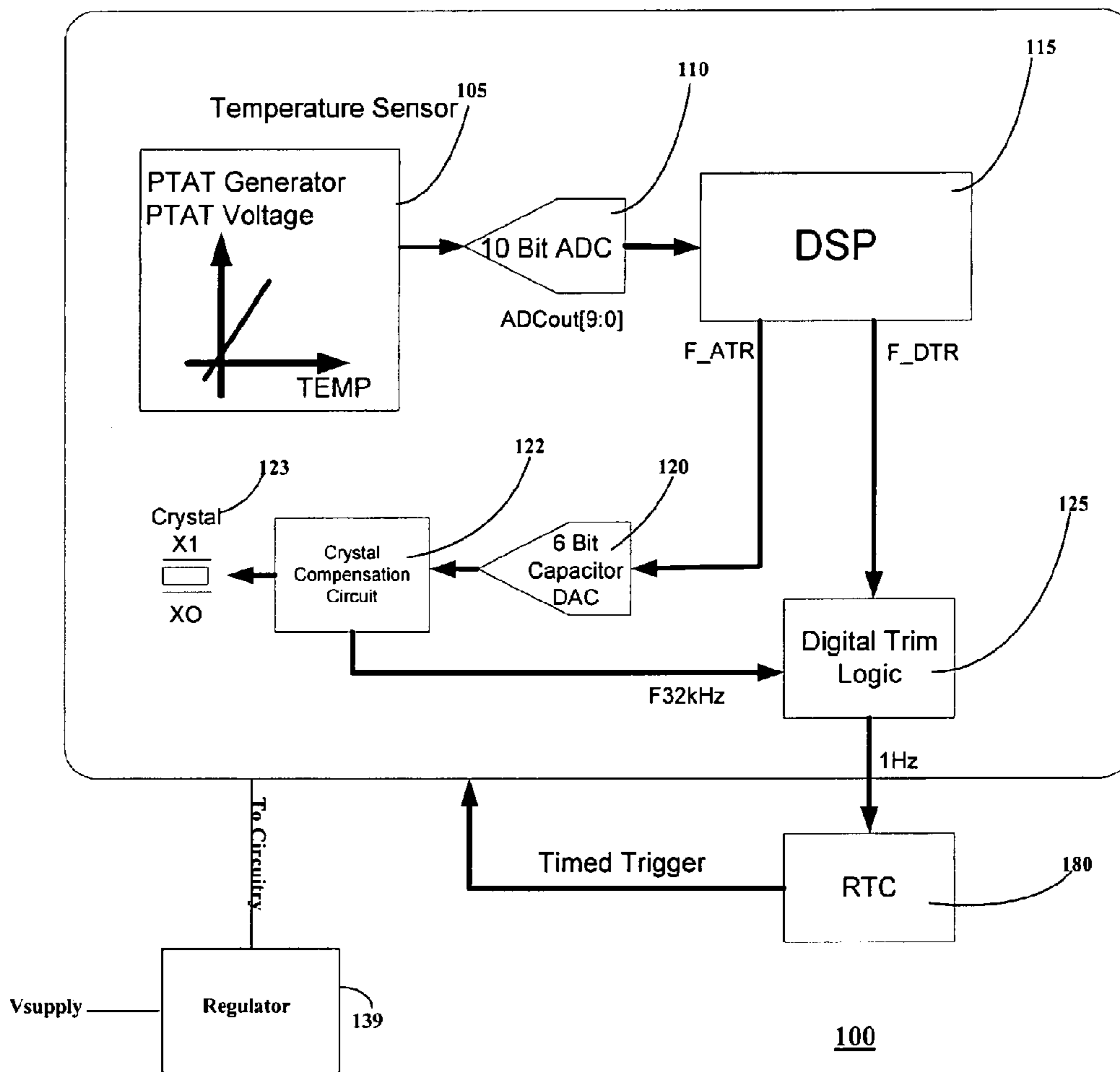


FIG. 3(a)

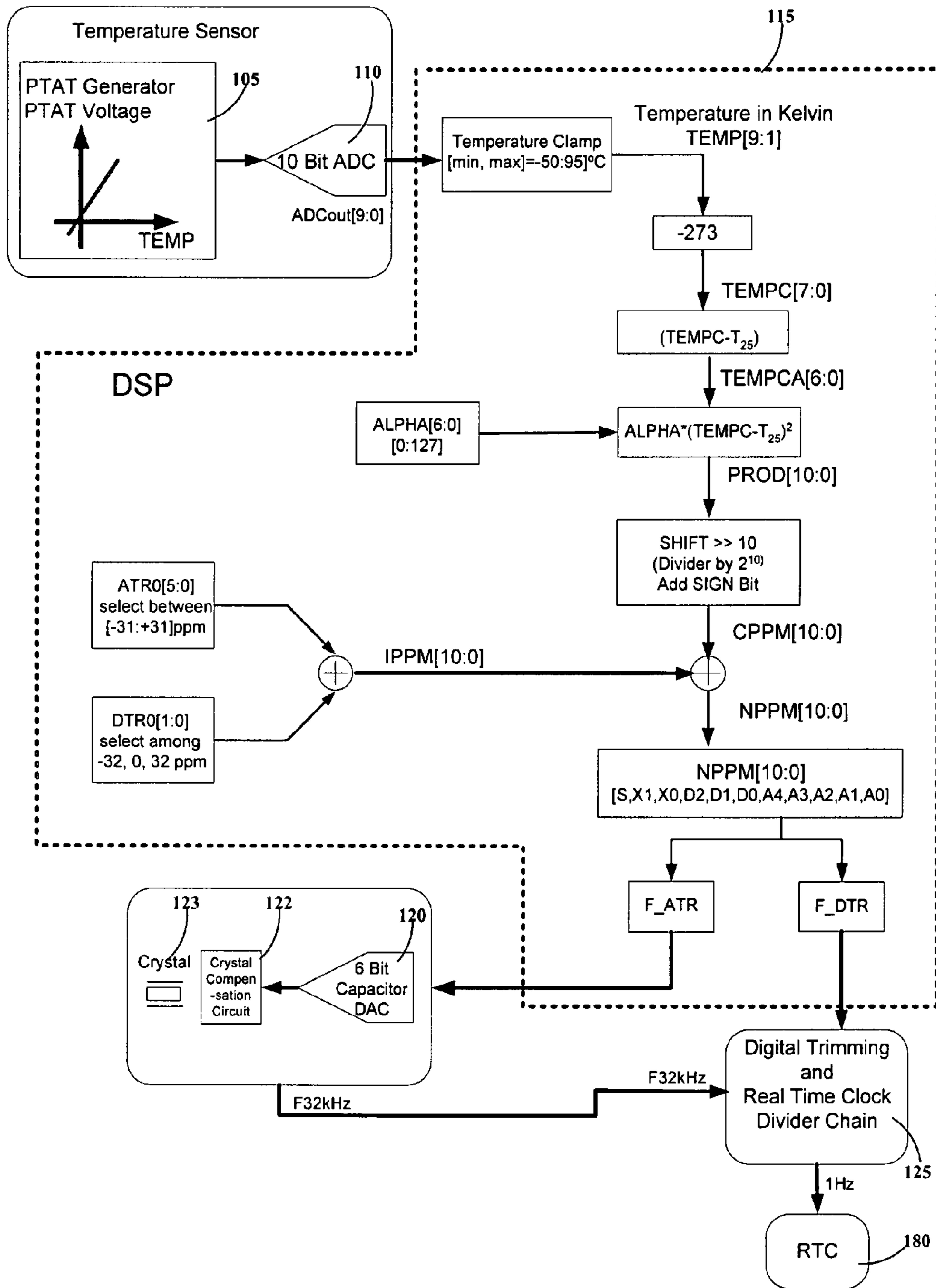
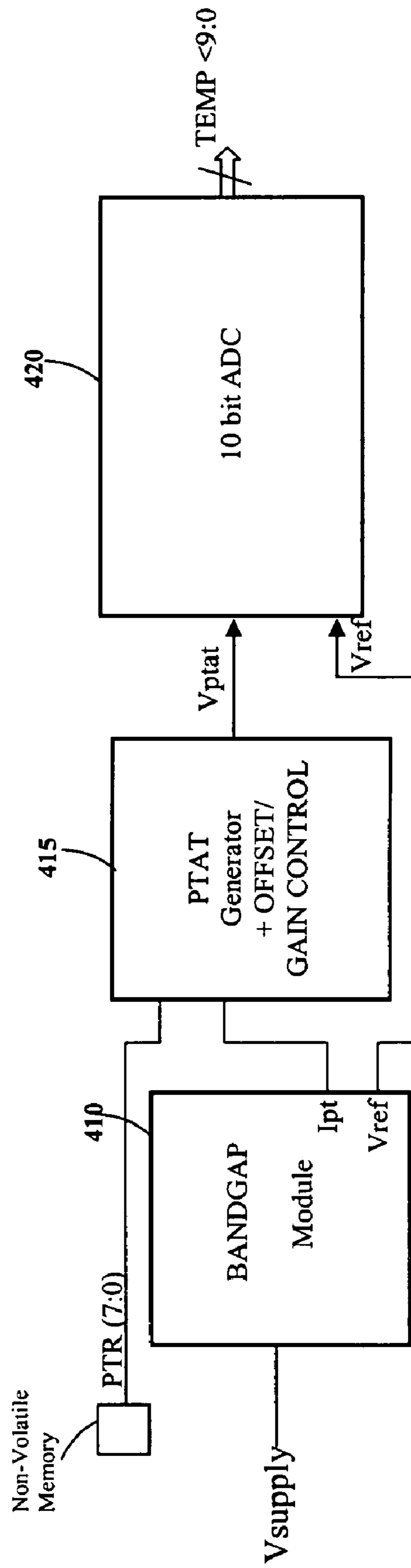
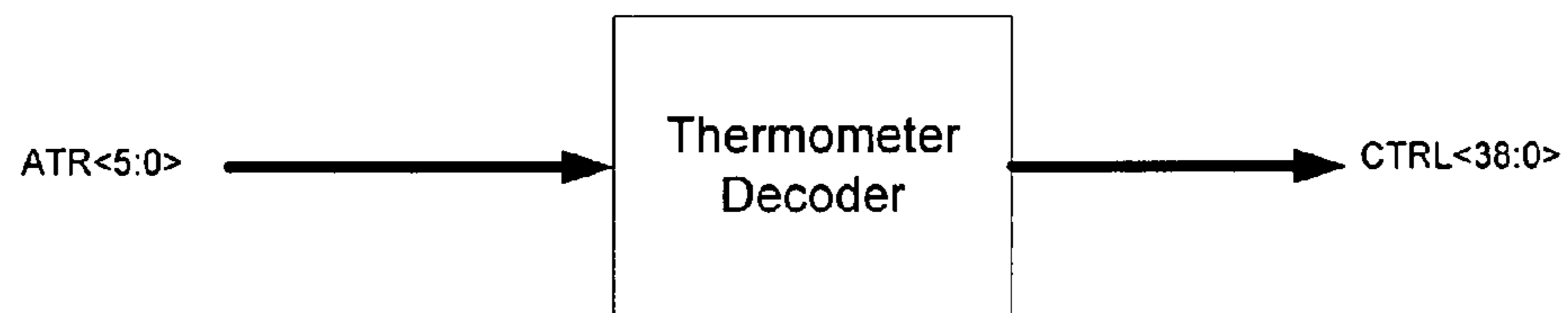


FIG. 3(b)



400

FIG. 4(a)

6-bit Thermometer Decoder

The detector generates controls for the switches associated with the capacitor DAC segments.

FIG. 4(b)

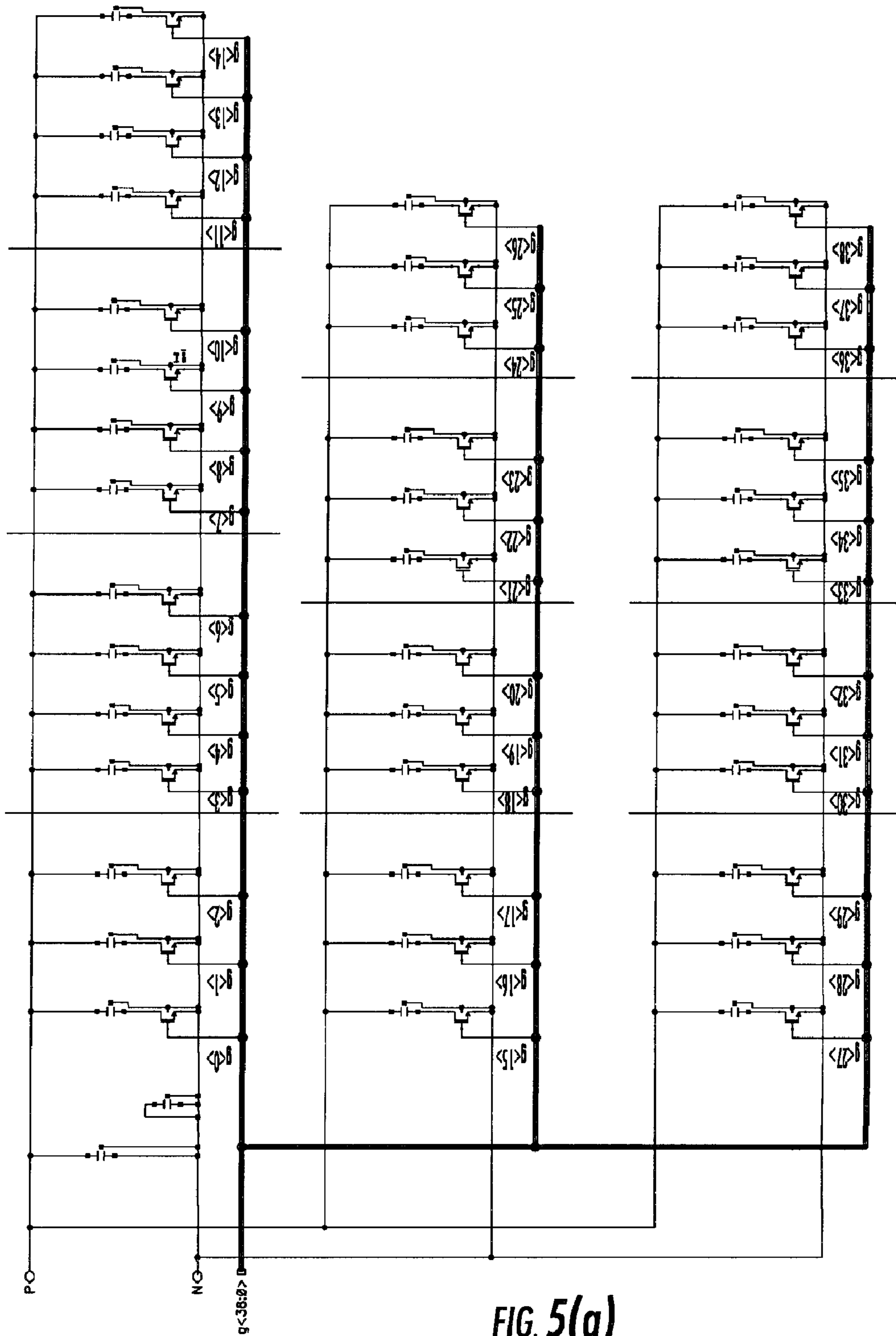


FIG. 5(a)

12 Capacitor DAC Segments

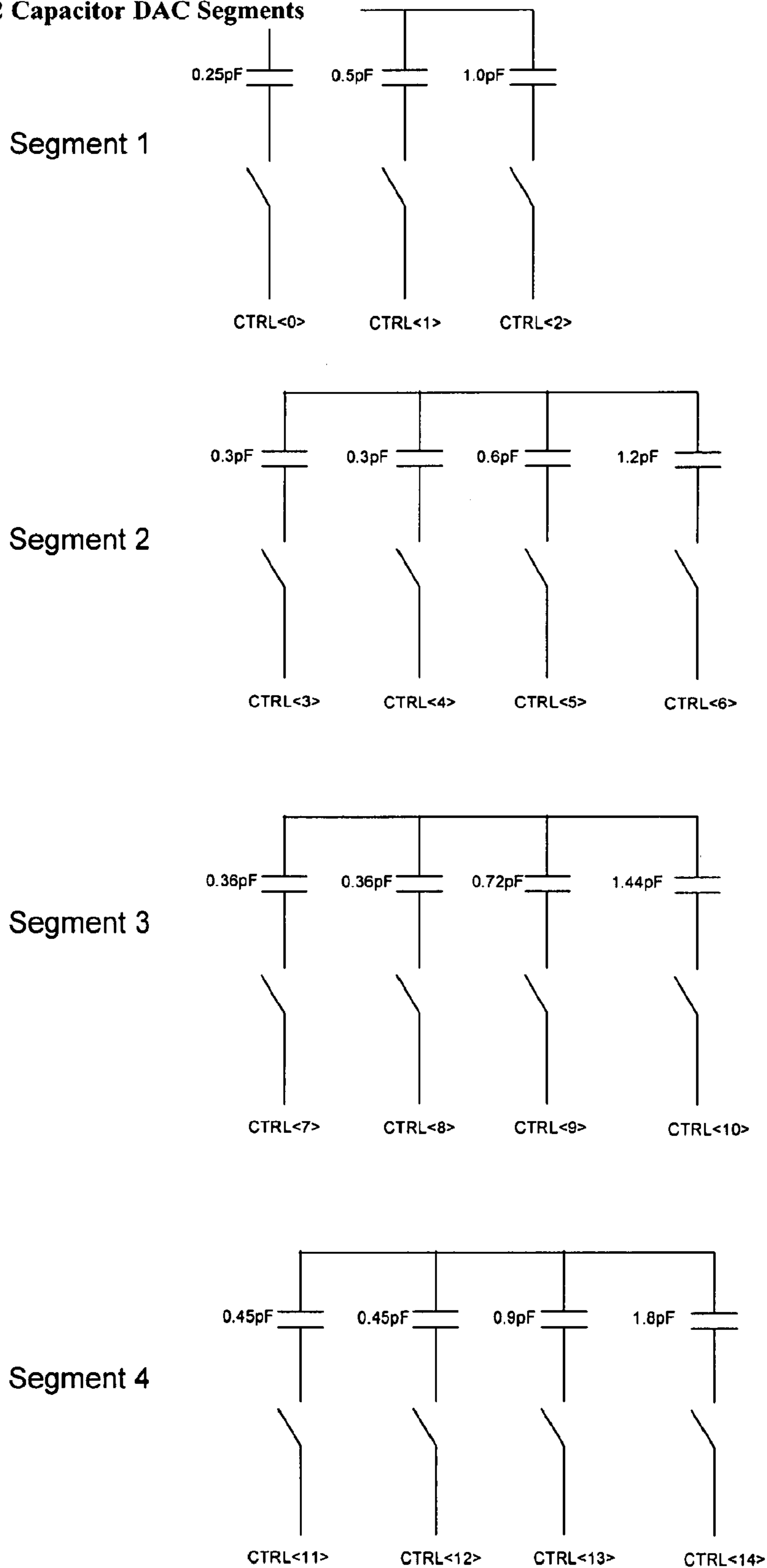


FIG. 5(b)

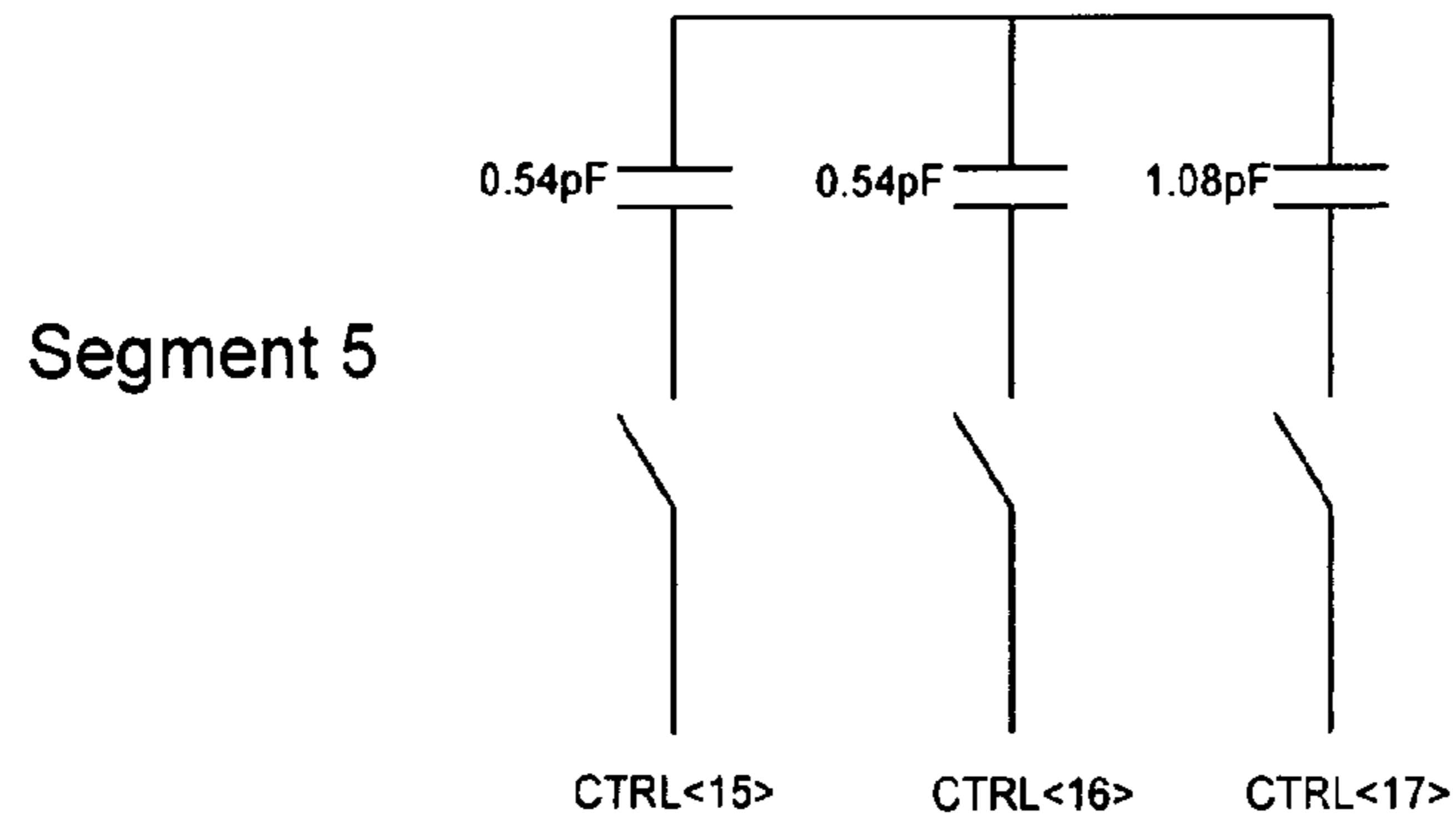
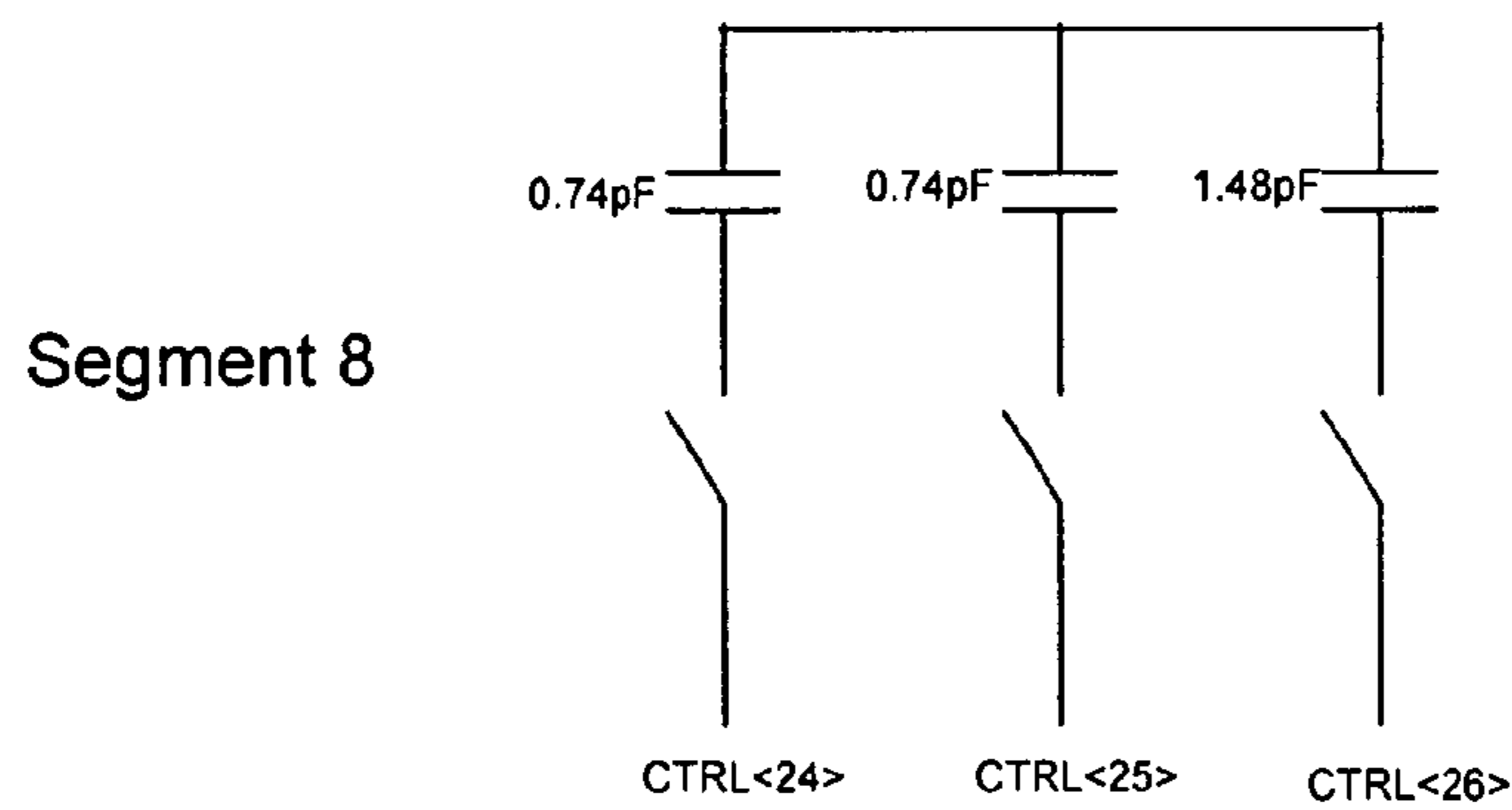
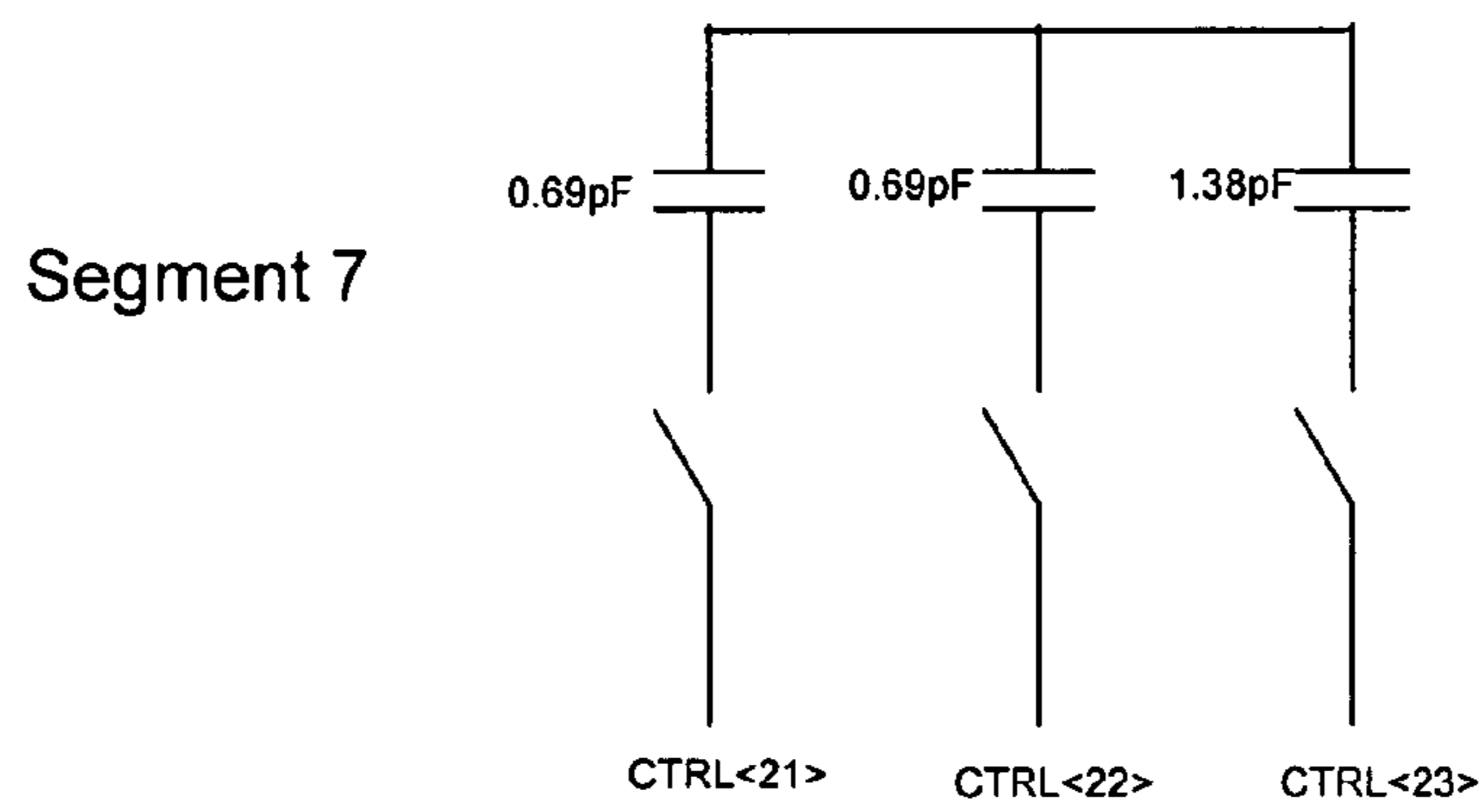
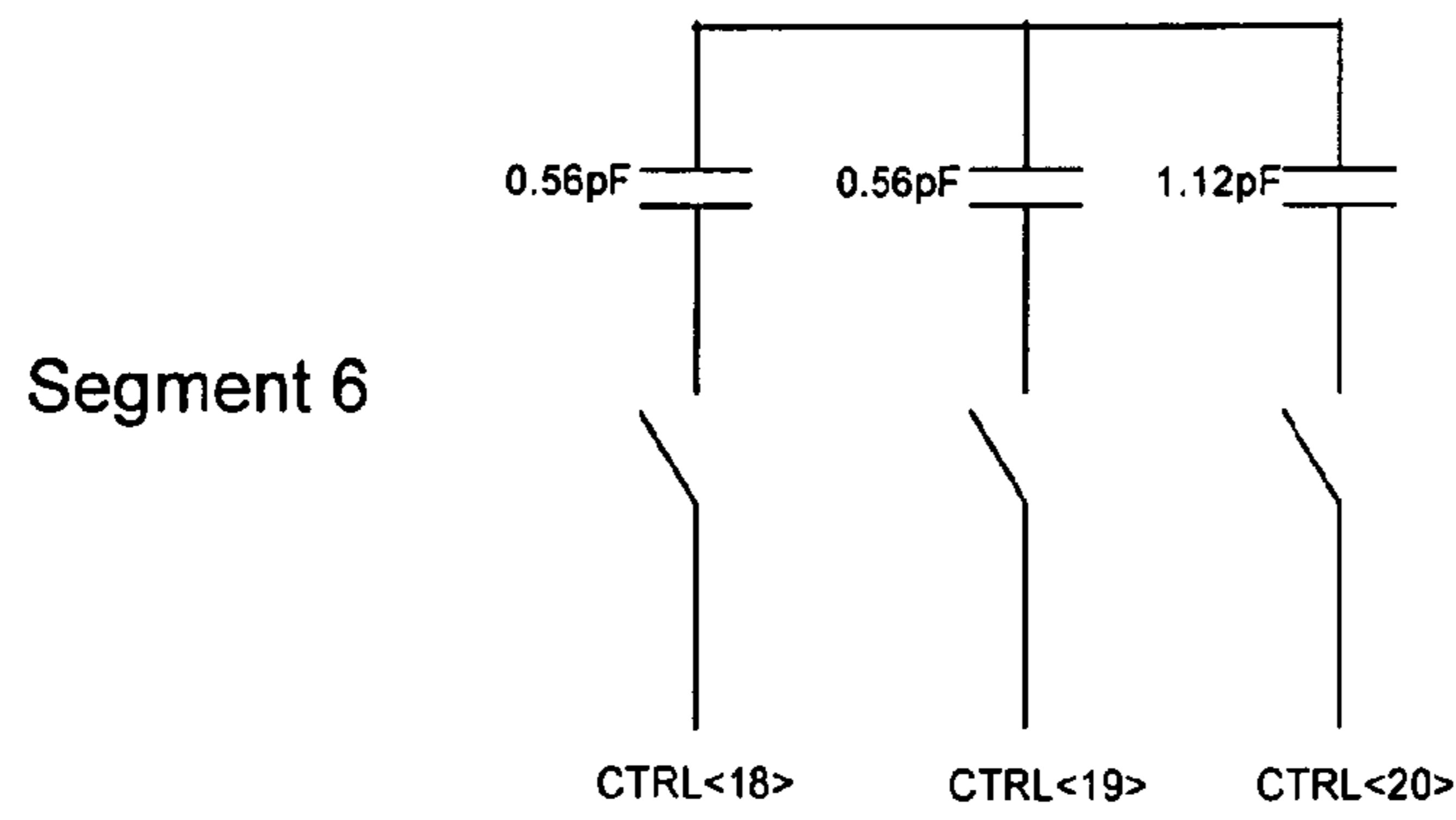


FIG. 5(b)



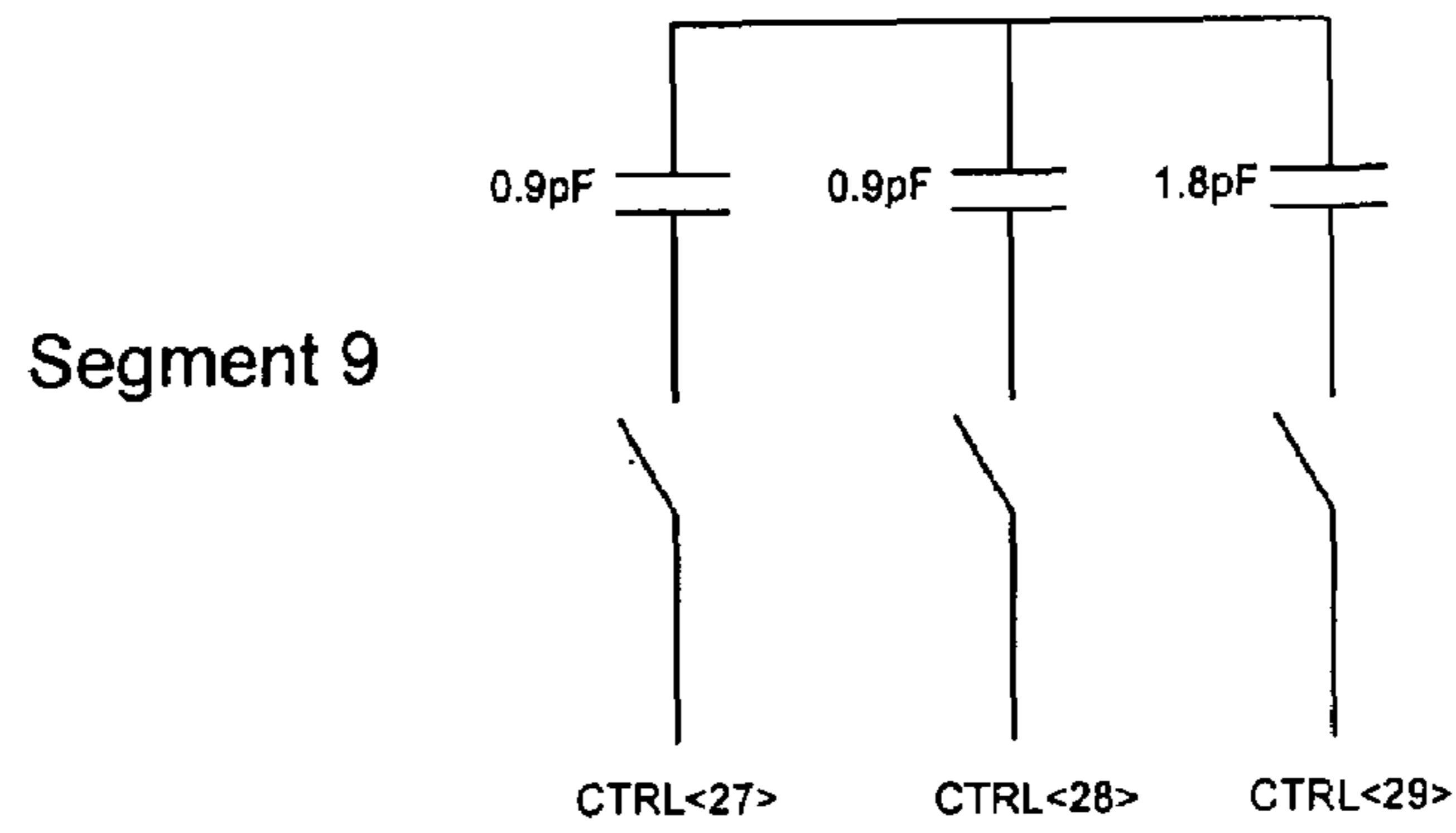
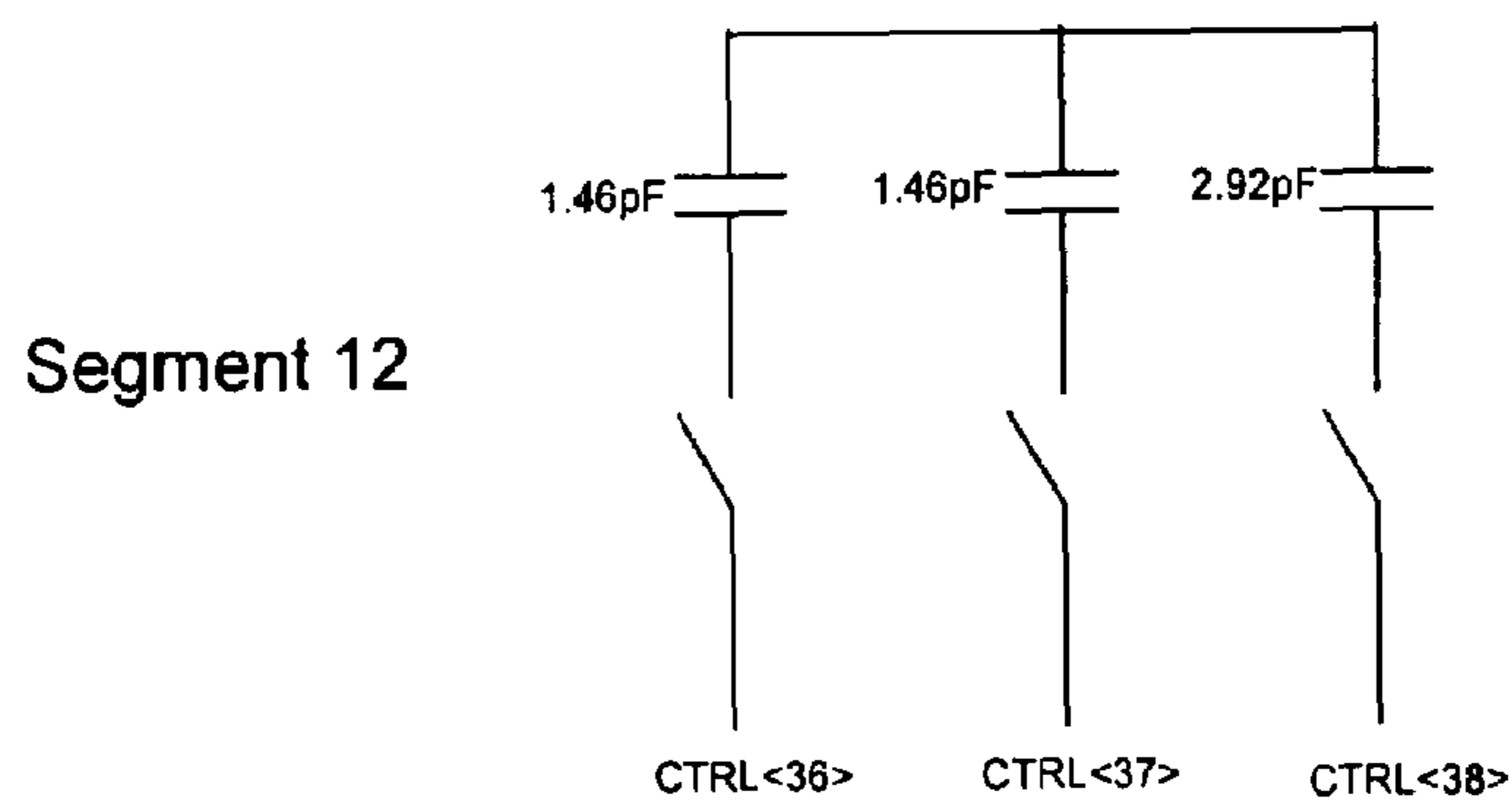
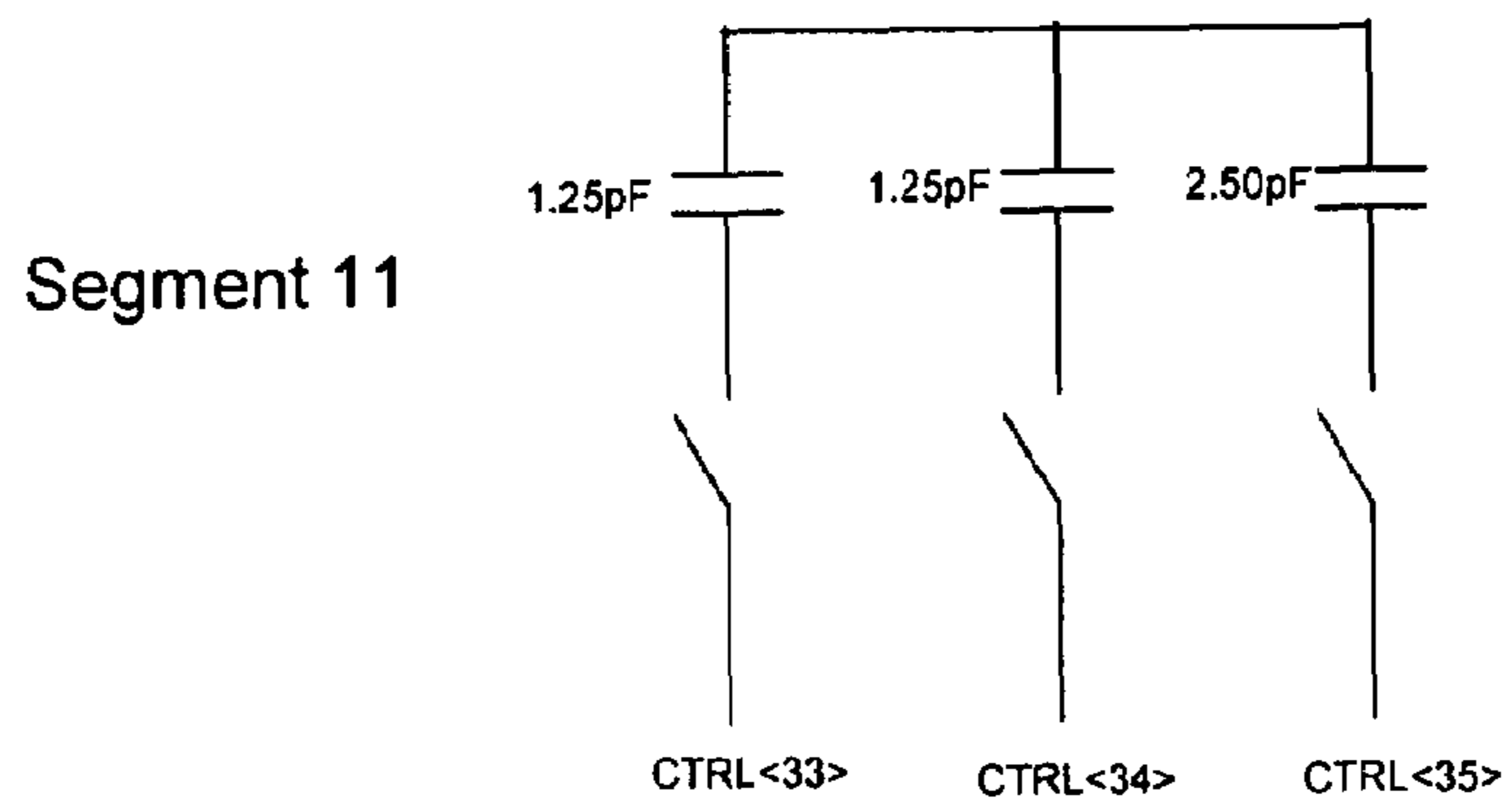
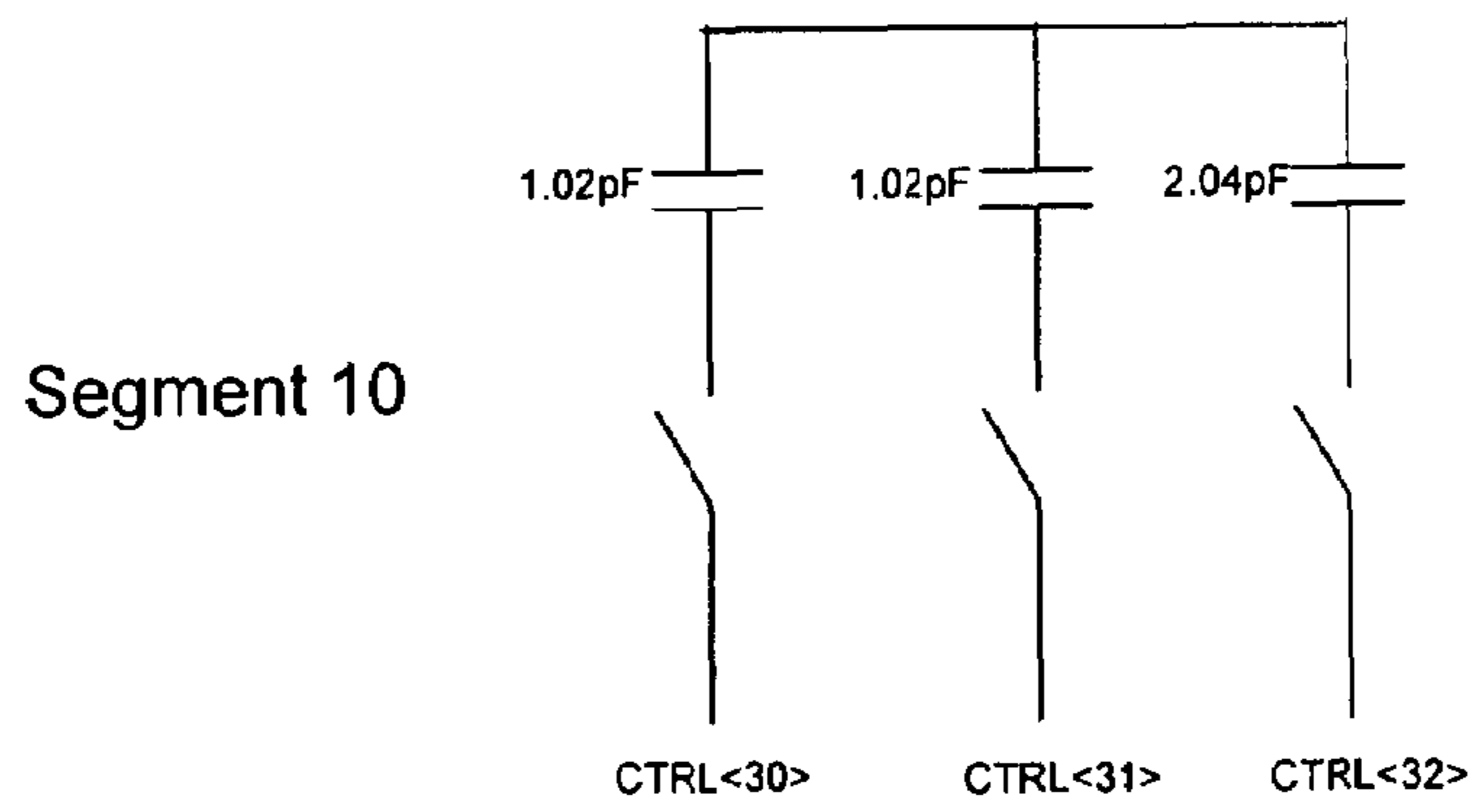


FIG. 5(b)



THE ATR trim is partitioned into 12 cap DACs.

code	ATR5	ATR4	ATR3	ATR2	ATR1	ATR0	C2	C1	C0	CL(pF)	delta CL(pF)	fp (Hz)
0	0	0	0	0	0	0				13.83	0	32769.220
1	0	0	0	0	0	1	1p	500f	250f	14.06	0.238	32769.181
2	0	0	0	0	1	0				14.31	0.481	32769.142
3	0	0	0	0	1	1				14.55	0.729	32769.104
4	0	0	0	1	0	0				14.81	0.982	32769.065
5	0	0	0	1	0	1				15.07	1.241	32769.026
6	0	0	0	1	1	0				15.33	1.505	32768.988
7	0	0	0	1	1	1				15.60	1.775	32768.949
8	0	0	1	0	0	0	1.2p	600f	300f	15.88	2.051	32768.910
9	0	0	1	0	0	1				16.16	2.333	32768.872
10	0	0	1	0	1	0				16.45	2.621	32768.834
11	0	0	1	0	1	1				16.74	2.917	32768.795
12	0	0	1	1	0	0				17.04	3.219	32768.757
13	0	0	1	1	0	1				17.35	3.528	32768.719
14	0	0	1	1	1	0				17.67	3.844	32768.680
15	0	0	1	1	1	1				17.99	4.168	32768.642
16	0	1	0	0	0	0	1.44p	720f	360f	18.33	4.500	32768.604
17	0	1	0	0	0	1				18.67	4.840	32768.566
18	0	1	0	0	1	0				19.01	5.189	32768.528
19	0	1	0	0	1	1				19.37	5.546	32768.490
20	0	1	0	1	0	0				19.74	5.913	32768.452
21	0	1	0	1	0	1				20.11	6.289	32768.414
22	0	1	0	1	1	0				20.50	6.674	32768.376
23	0	1	0	1	1	1				20.90	7.071	32768.338
24	0	1	1	0	0	0	1.8p	900f	450f	21.30	7.477	32768.301
25	0	1	1	0	0	1				21.72	7.895	32768.263
26	0	1	1	0	1	0				22.15	8.325	32768.225
27	0	1	1	0	1	1				22.59	8.766	32768.188
28	0	1	1	1	0	0				23.05	9.221	32768.150
29	0	1	1	1	0	1				23.51	9.688	32768.112
30	0	1	1	1	1	0				23.99	10.169	32768.075
31	0	1	1	1	1	1				24.49	10.664	32768.037
32	1	0	0	0	0	0		1.08p	540f	25.00	11.175	32768
33	1	0	0	0	0	1				25.51	11.685	32767.964
34	1	0	0	0	1	0				26.04	12.211	32767.927
35	1	0	0	0	1	1				26.58	12.752	32767.891
36	1	0	0	1	0	0		1.12p	560f	27.14	13.311	32767.855
37	1	0	0	1	0	1				27.71	13.886	32767.819
38	1	0	0	1	1	0				28.31	14.480	32767.783
39	1	0	0	1	1	1				28.92	15.093	32767.747
40	1	0	1	0	0	0		1.38p	690f	29.55	15.726	32767.711
41	1	0	1	0	0	1				30.21	16.380	32767.675
42	1	0	1	0	1	0				30.88	17.056	32767.639
43	1	0	1	0	1	1				31.58	17.756	32767.604
44	1	0	1	1	0	0		1.48p	740f	32.30	18.480	32767.568
45	1	0	1	1	0	1				33.05	19.229	32767.532
46	1	0	1	1	1	0				33.83	20.006	32767.497
47	1	0	1	1	1	1				34.64	20.811	32767.461

FIG. 6(a)

code	ATR5	ATR4	ATR3	ATR2	ATR1	ATR0	C2	C1	C0	CL(pF)	delta CL(pF)	fp (Hz)
48	1	1	0	0	0	0	1.8p	900f		35.47	21.647	32767.426
49	1	1	0	0	0	1				36.34	22.514	32767.391
50	1	1	0	0	1	0				37.24	23.416	32767.355
51	1	1	0	0	1	1				38.18	24.353	32767.320
52	1	1	0	1	0	0	2.04p	1.02p		39.15	25.328	32767.285
53	1	1	0	1	0	1				40.17	26.343	32767.250
54	1	1	0	1	1	0				41.23	27.402	32767.214
55	1	1	0	1	1	1				42.33	28.506	32767.179
56	1	1	1	0	0	0	2.50p	1.25p		43.48	29.658	32767.144
57	1	1	1	0	0	1				44.69	30.862	32767.110
58	1	1	1	0	1	0				45.95	32.122	32767.075
59	1	1	1	0	1	1				47.27	33.441	32767.040
60	1	1	1	1	0	0	2.92p	1.46p		48.65	34.823	32767.005
61	1	1	1	1	0	1				50.10	36.274	32766.971
62	1	1	1	1	1	0				51.62	37.798	32766.936
63	1	1	1	1	1	1				53.23	39.401	32766.901

FIG. 6(a)

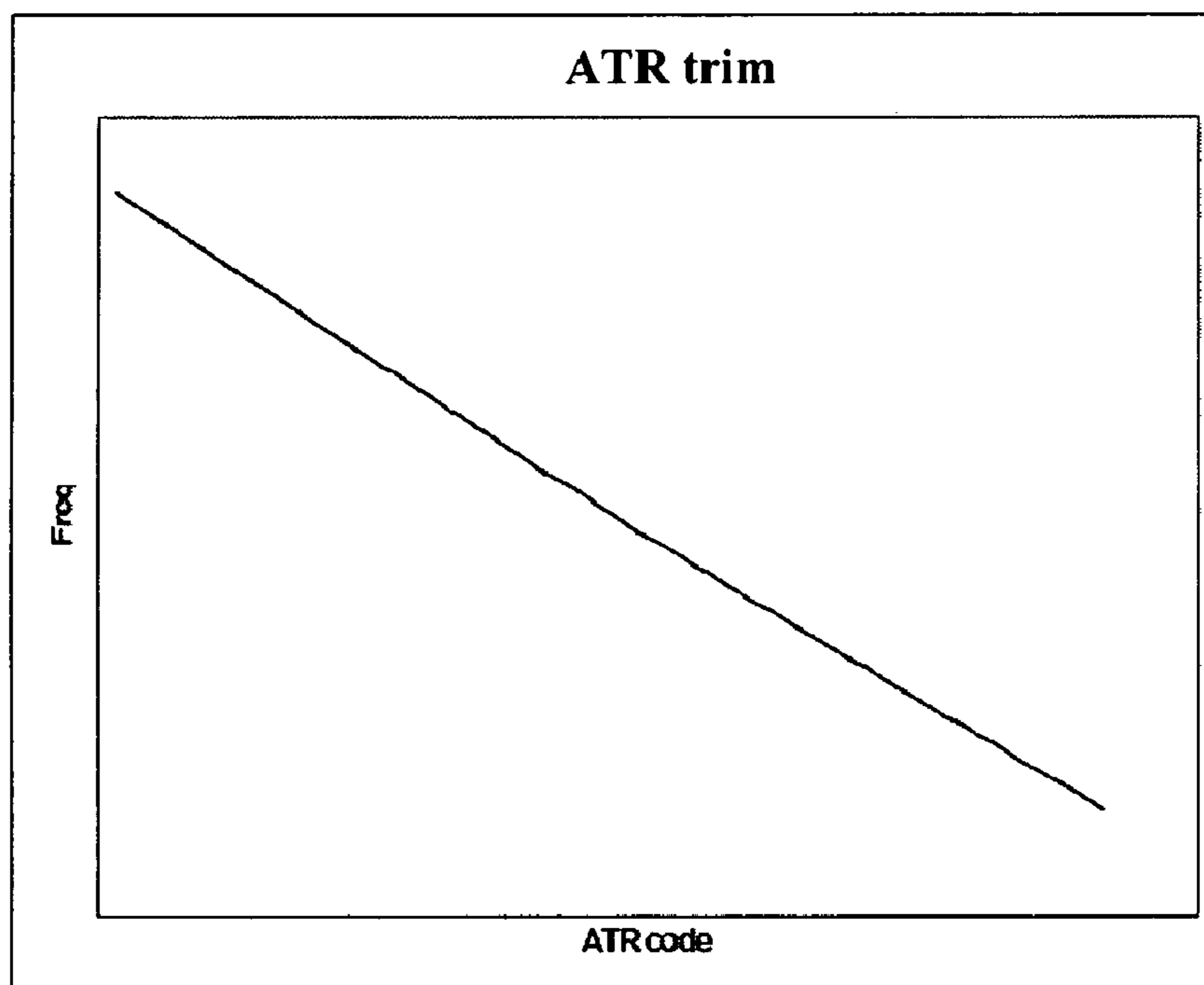


FIG. 6(b)

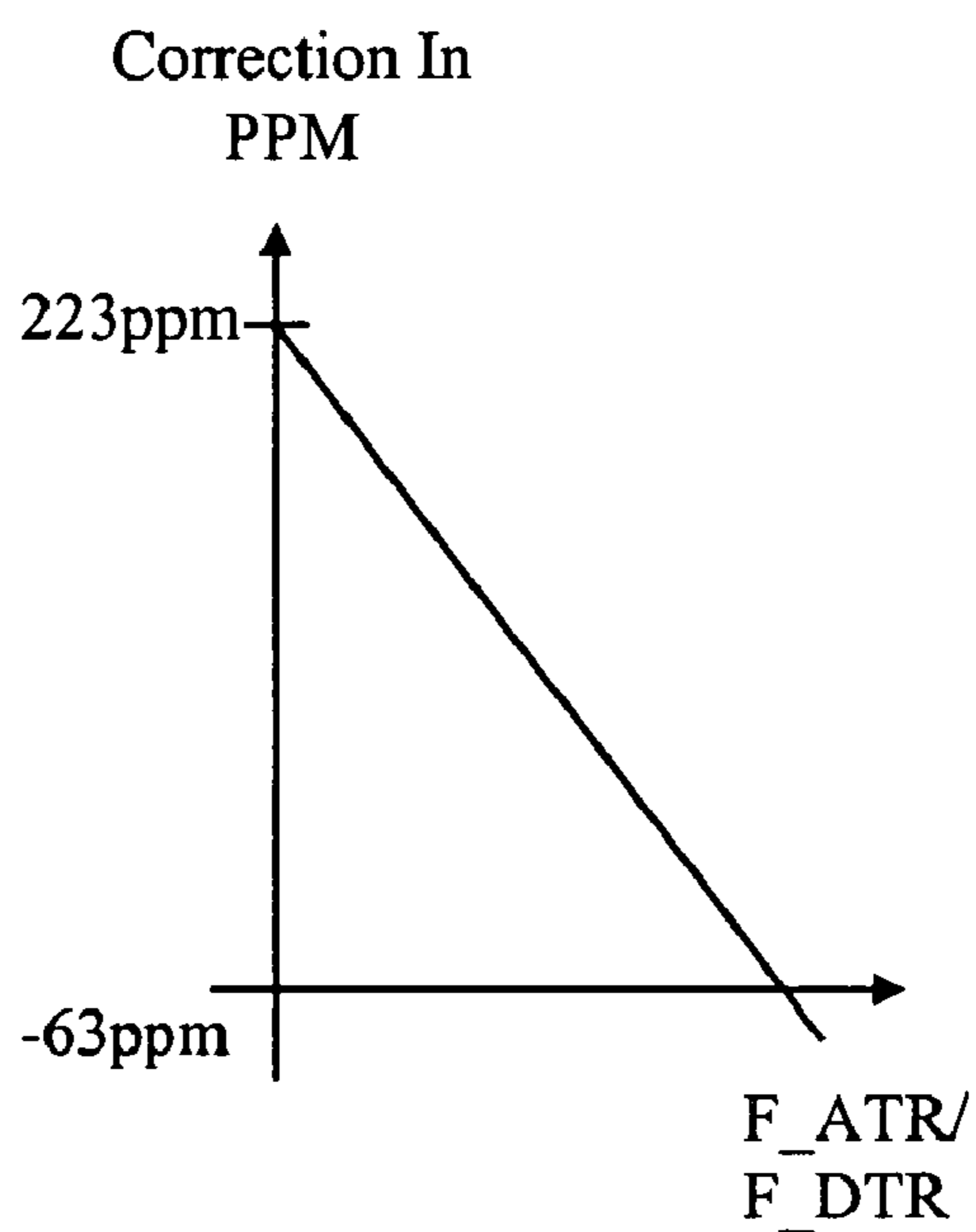


FIG. 6(c)

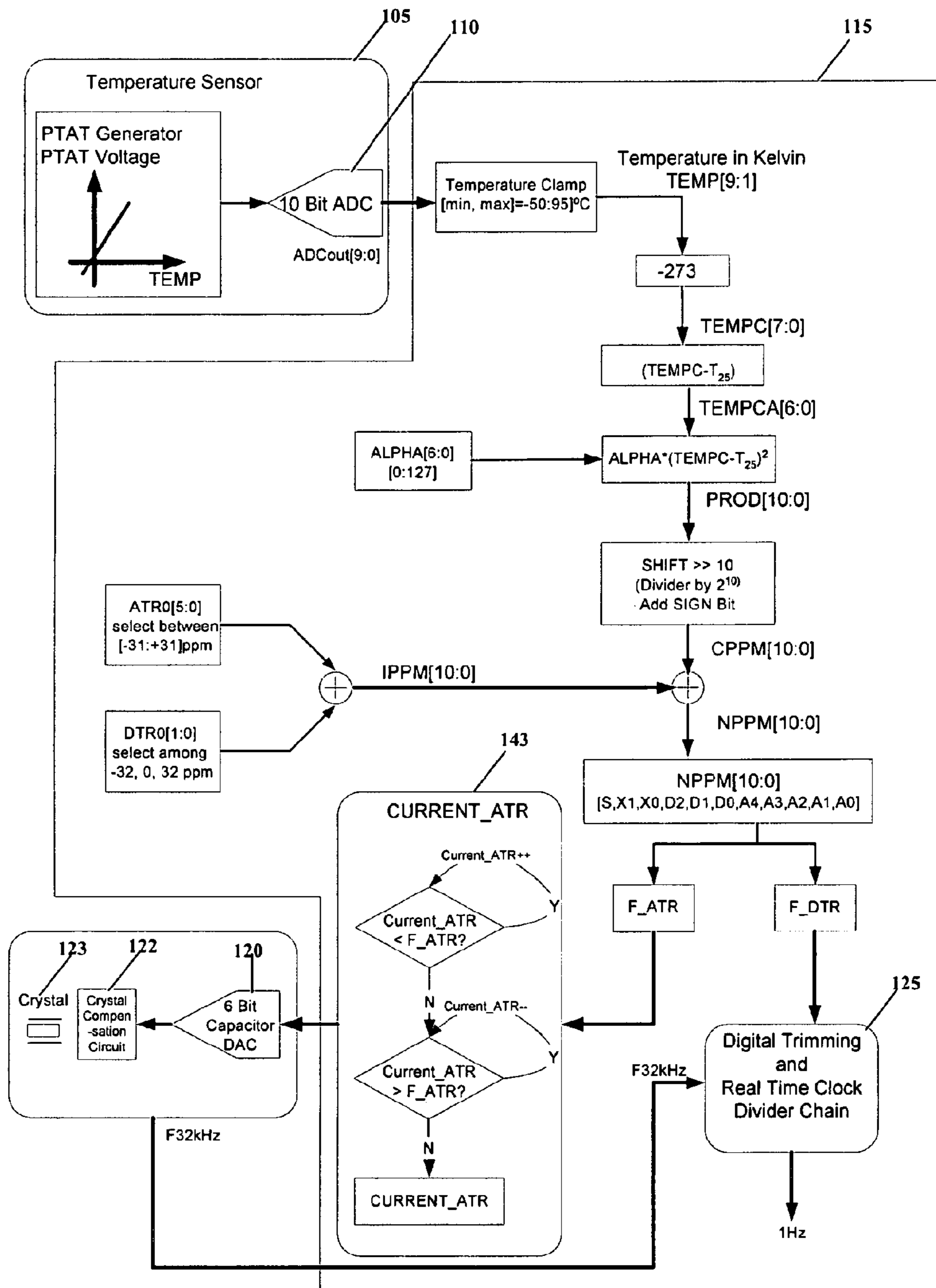


FIG. 7

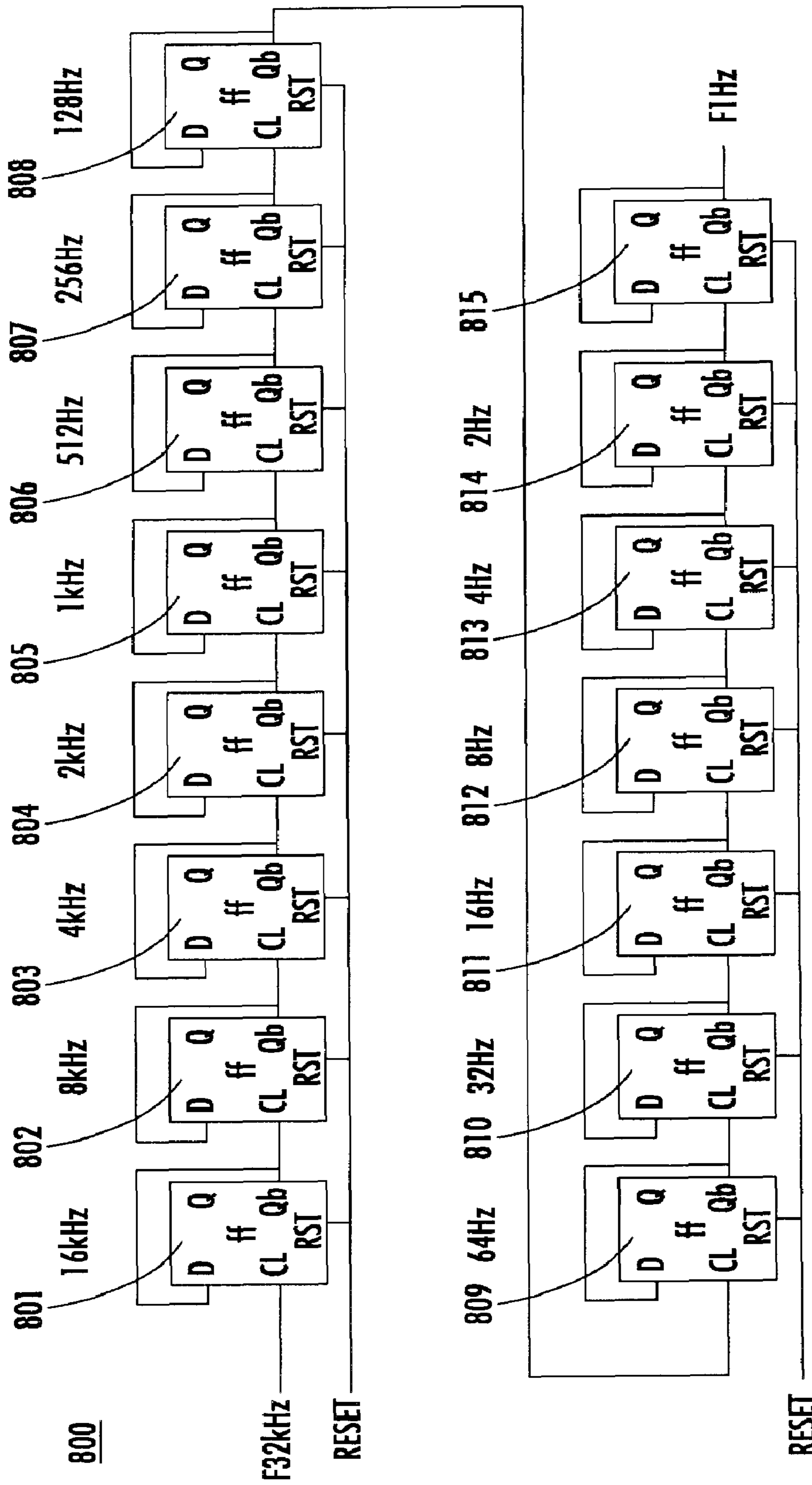


FIG. 8(a)

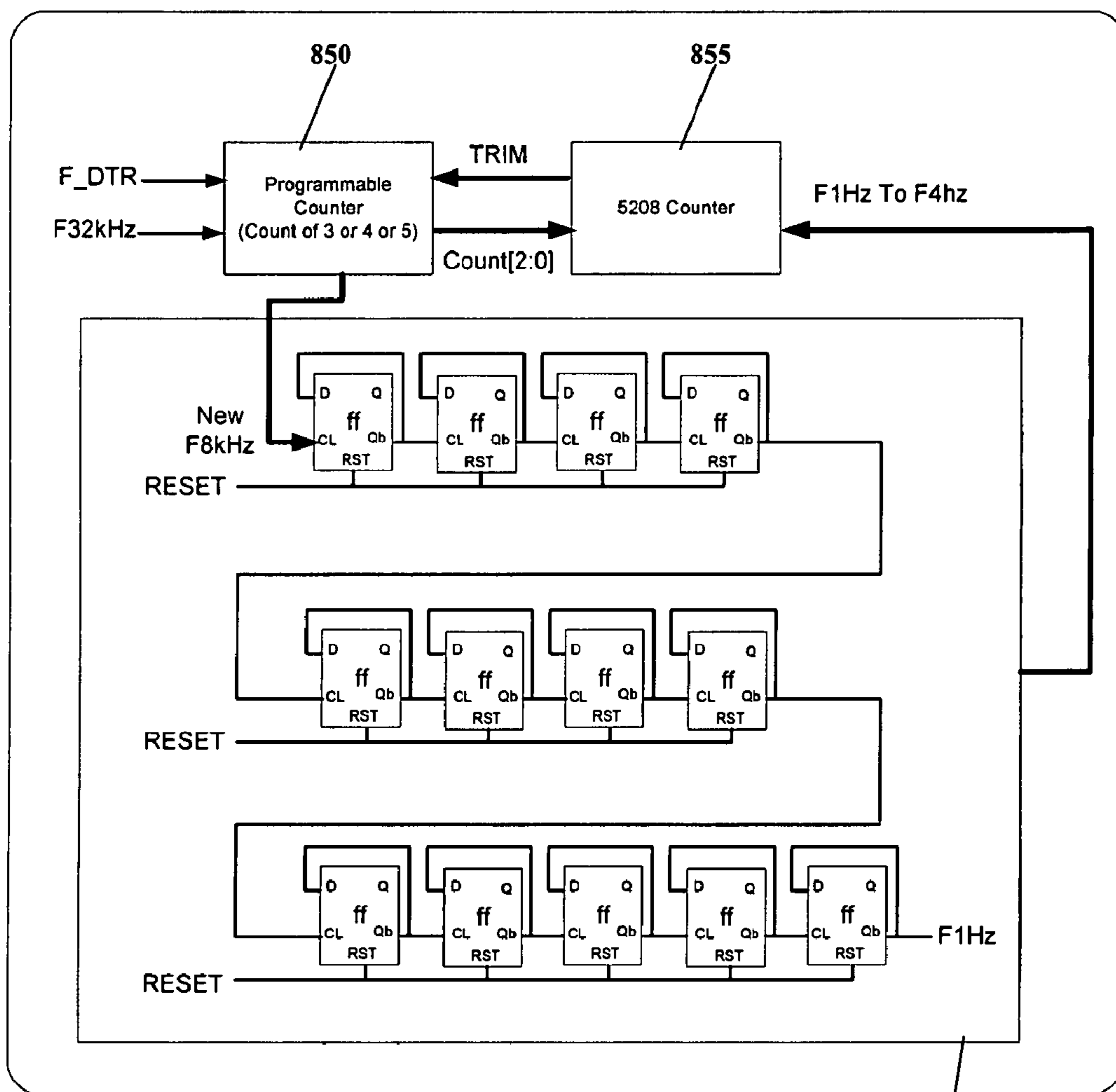


FIG. 8(b)

860

840

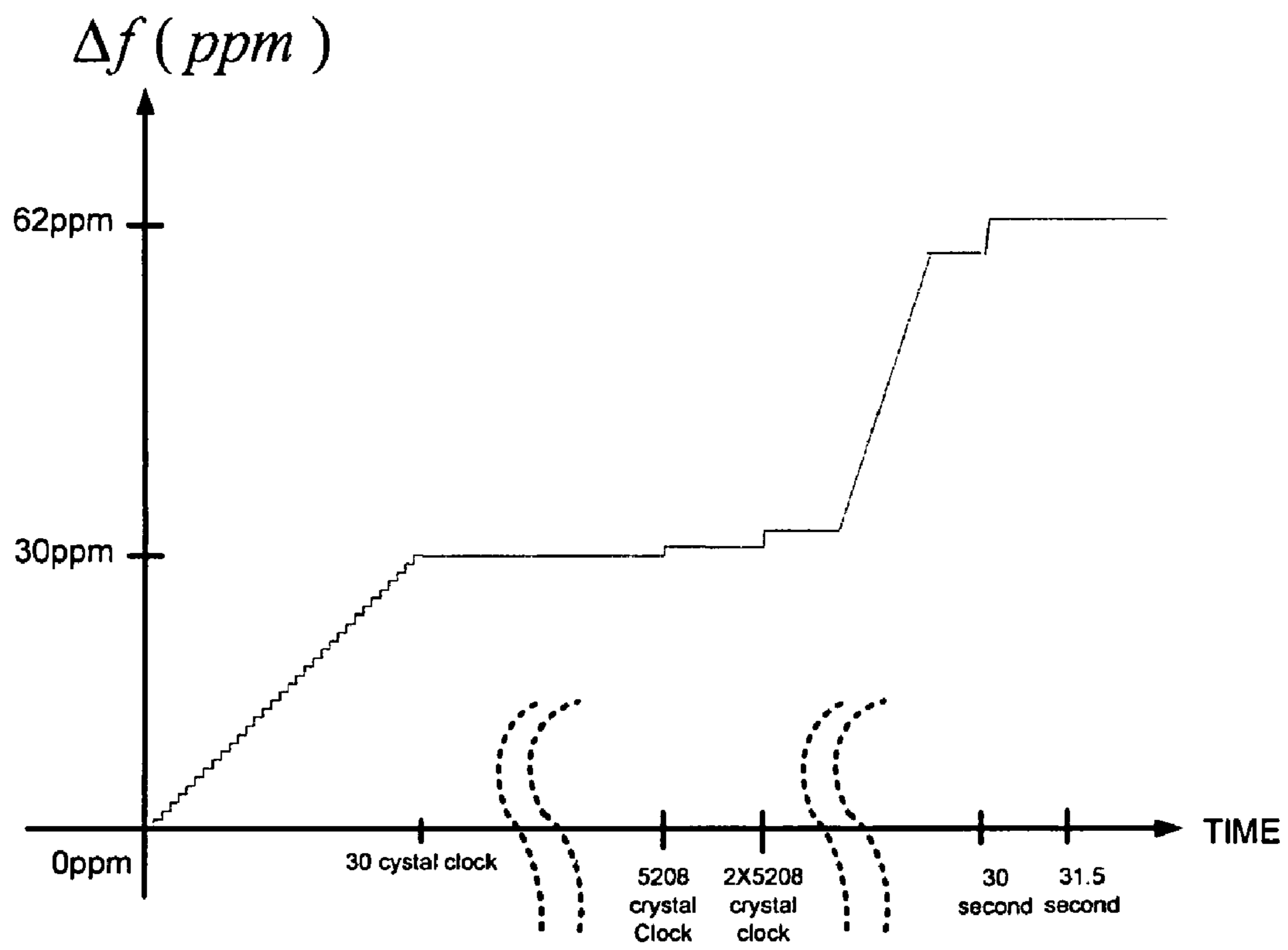


FIG. 8(c)

**AUTOMATIC CIRCUIT AND METHOD FOR
TEMPERATURE COMPENSATION OF
OSCILLATOR FREQUENCY VARIATION
OVER TEMPERATURE FOR A REAL TIME
CLOCK CHIP**

Matter enclosed in heavy brackets [] appears in the original patent but forms no part of this reissue specification; matter printed in italics indicates the additions made by reissue.

CROSS-REFERENCE TO RELATED
APPLICATIONS

This application claims the benefit of Provisional Application No. 60/859,396 filed on Nov. 16, 2006 and Provisional Application No. 60/869,683 filed on Dec. 12, 2006, both entitled "AUTOMATIC CIRCUIT AND METHOD FOR TEMPERATURE COMPENSATION OF OSCILLATOR FREQUENCY VARIATION OVER TEMPERATURE FOR A REAL TIME CLOCK CHIP", both being incorporated by reference in their entireties into the present application.

FIELD OF THE INVENTION

The invention relates to electronic devices, and, more particularly, to timekeeping devices useful in personal computers and other consumer electronics, as well as networking devices.

BACKGROUND OF THE INVENTION

Personal computers typically include a clock/calendar that tracks the time of day, day, month, and year. Such a clock/calendar has various uses such as time stamping files and inserting dates into documents, such as letters and e-mails both sent and received. The clock/calendar must be programmable for setting or changing the date or time of day. A clock/calendar is typically implemented in specific hardware with a dedicated crystal oscillator to insure accuracy and a battery backup power supply to insure preservation of timekeeping data during an interruption of the primary power supply. This is especially important with personal computers which are frequently powered down.

Crystals generally show frequency variation with temperature resulting into several hundred ppm shift in their nominal frequency. Most applications, in particular, a Real Time Clock (RTC), requires accuracy of the input clock to be within ± 5 ppm over a temperature range of -40 to 85° C. in order to provide accurate time information to the user.

An RTC with a 32.768 kHz quartz tuning-fork crystal oscillator is currently the standard timekeeping reference for most electronic applications. The RTC maintains the time and date by counting seconds, which requires an oscillator divider chain to derive a 1 Hz clock signal provided by the 32.768 kHz crystal oscillator. The current time and date information is stored in a set of registers, which is generally accessed through a communication interface.

Tuning fork type crystal oscillators are known to have both a frequency offset at room temperature and frequency variation over temperature, typically resulting into several hundred ppm frequency shift from their nominal frequency of 32.768 kHz. These frequency offsets can be broken into two portions, one being the initial frequency inaccuracy, with the other

being the frequency fluctuation over temperature. The typical frequency stability of a crystal can be described by equation (1) below:

$$\Delta f = \Delta f_i + \alpha(T - T_{25})^2 \quad (1)$$

Where Δf is in the total frequency variation in ppm; Δf_i is the initial frequency tolerance at 25° C., which usually within the range of ± 32 ppm; α is the parabolic curvature constant of the crystal, for the commonly used quartz watch crystal, α has a typical value of 0.034 ppm/ C^2 for quartz; T is temperature in Celsius and T_{25} is 25° C. This parabolic frequency versus temperature characteristic is depicted in FIG. 1.

Δf_i is the constant frequency offset due to the manufacturing quality issues and aging of the crystal. The value of the second term in equation 1, $\alpha(T - T_{25})^2$, is determined by a which is a characteristic of the particular crystalline material, and the operating temperature. Both terms combined could contribute to a frequency variation up to about 200 ppm. For an RTC, 100 ppm in the frequency variation implies that there is about 120 seconds (about 2 minutes) of error at the end of a month's time.

It is well known to use load capacitors to adjust the parallel resonance frequency, f_0 , of crystal oscillators. This frequency, f_0 , has an inverse square root relationship to load capacitor (C_L) changes. For on-chip load capacitor designs, some known designs use switched capacitor arrays controlled digitally by input code vectors. Such capacitor arrays are known as capacitor digital-to-analog converters (referred to as capacitor DACs, capacitive DACs or CDACs). A conventional capacitor DAC comprises of an array of N capacitors hooked in parallel with binary weighted values plus generally one "dummy LSB" capacitor. During the acquisition phase, the array's common terminal (the terminal at which all the capacitors share a connection) is connected to ground and all free terminals are connected to the input signal (Analog In or V_{IN}). After acquisition, the common terminal is disconnected from ground and the free terminals are disconnected from V_{IN} , effectively trapping a charge proportional to the input voltage on the capacitor array. Due to the binary weighting and conventional digital code used, in response to the applied digital input codes, such DACs provide a linear analog output (capacitance).

Some RTCs provide a digital calibration register that can be used to periodically adjust the time of day in discrete amounts. This method does not attempt to alter the crystal behavior, but instead, periodically adjusts the time according to the expected frequency deviation at a specified temperature. The effect is to move the 32.768 kHz parabolic curve up or down in an attempt to approach 0.0 ppm accuracy at a desired temperature. This is accomplished by adding or subtracting clock cycles from the oscillator divider chain. The number of clock pulses removed (subtracted for negative calibration) or inserted (added for positive calibration) is set by the value in the calibration register. By adding clock pulses, time is sped up (the crystal curve moves up). In contrast, by subtracting clock pulses, time is slowed down (the crystal curve moves down).

Another method dynamically changes the load capacitance to "trim" the crystal frequency. One known RTC circuit of this type includes a 6-bit capacitor DAC that provides a delta of 0.5 pF for each code which is used to trim the frequency. In such an arrangement, due to the well known nonlinear frequency to CL relationship, changing CL linearly results in a nonlinear change in frequency. For precision applications requiring better than ± 5 ppm precision over a normal operating temperature range, such a non-linear frequency trim arrangement generally cannot meet the requirement.

A linear frequency shift per input code would be desirable as it would provide improved precision. However, due to the nonlinear frequency to CL relationship, the input code vectors would need to be nonlinear and more specifically parabolic to provide a linear frequency shift. Using known methods, this would require nonlinear digital signal processing which can be complex, and also generally requires a large chip area and significant power consumption. Thus, what is needed is a compact, low power RTC circuit which does not require factory calibration and automatically provides a minimal frequency variation over the full RTC operating temperature range, such as within ± 5 ppm from -40 to 85° C.

SUMMARY

This Summary is provided to comply with 37 C.F.R. §1.73, requiring a summary of the invention briefly indicating the nature and substance of the invention. It is submitted with the understanding that it will not be used to interpret or limit the scope or meaning of the claims.

An automatic temperature compensated real-time clock (RTC) chip includes a clock portion having a crystal oscillator block including crystal compensation circuitry adapted to be coupled to a crystal. The crystal compensation circuitry includes a non-linear capacitor DAC including a plurality of load capacitors, wherein the load capacitors have respective switches which switch respective ones of the load capacitors to change a parallel resonance frequency (f_p) generated by the oscillator block. The capacitor DAC is arranged so that Analog Trimming (ATR) bits received cause an arrangement of the switches to provide a non-linear change in overall load capacitance to result in a linear relationship between f_p and the ATR bits. A temperature sensor block is coupled to the crystal for measuring a temperature of at least the crystal. An A/D converter is coupled to the temperature sensor for outputting a digital temperature signal representative of the temperature of the crystal. A DSP engine receives the digital temperature signal and calculates frequency correction needed to correct for frequency inaccuracy and determines a bit sequence including the ATR bits appropriate to achieve the frequency correction.

The non-linear DAC can comprise a piecewise linear segmented DAC, comprising a plurality of piecewise linear segments connected in parallel. In this embodiment, the plurality of segments can be binary weighted segments. Some of the plurality of segments are controlled by a first number of ATR bits and other of the segments are controlled by a different number of ATR bits. The RTC can further comprise thermometer decoder logic for receiving the ATR bits and generating a plurality of control lines for controlling the switches.

The DSP calculation preferably splits the frequency correction into ATR bits and into coarser Digital Trimming (DTR) bits, wherein the digital trimming bits are operable to perform frequency correction by adding or skipping clock cycles. In this embodiment, the RTC can further comprise an RTC digital trimming module including a clock divider chain for generating a 1 Hz clock from f_p , wherein the DTR bits are coupled to an input of the digital trimming module, the digital trimming module performing frequency adjustment on the 1 Hz clock.

The temperature sensor block can comprise a delta V_{be} -based temperature sensor (delta V_{be} -based temperature sensors are also known in the art as bandgap references). The temperature sensor block can further comprise a PTAT block coupled between the V_{be} -based temperature sensor and the A/D converter, wherein process trim (PTR) bits coupled to the PTAT trim at least one of offset and gain for the A/D converter.

RTC and related circuits according to the invention provide low power operation. The RTC chip generally runs at an average current of $<1 \mu\text{A}$ and an average power of $<5 \mu\text{W}$. In one embodiment, the RTC chip includes a buck voltage regulator for stepping down a supply voltage received by the chip to a lower level. The temperature sensor block can operate with a duty cycle of $<1:1,000$. The DSP module can be configured exclusive of hardware multipliers. The A/D converter can be a switched-capacitor based A/D converter.

A method for temperature compensating real time clocks comprises the steps of providing a real-time clock (RTC) having a crystal oscillator block comprising a crystal coupled to crystal compensation circuitry. The crystal compensation circuitry comprises a non-linear Capacitor DAC having a plurality of load capacitors having respective switches which switch respective ones of the load capacitors to change a parallel resonance frequency (f_p) generated by the oscillator block, wherein the capacitor DAC is arranged so that Analog Trimming (ATR) bits received cause an arrangement of the switches to provide a non-linear change in overall load capacitance resulting in a linear relationship between f_p and the ATR bits. The temperature of the crystal is measured. An input code comprising the ATR bits is generated based on the temperature to correct f_p . Frequency correction is implemented by applying input code vectors to the Capacitor DAC to provide a frequency shift to temperature correct an oscillator frequency of the crystal oscillator. The linear relationship between f_p and the ATR bits can comprise a constant integer/bit, such as 1 ppm/bit. In one embodiment, the generating step comprises generating Digital Trimming (DTR) in addition to the ATR bits, wherein the DTR bits provide a coarser frequency adjustment as compared to the ATR bits and operate by adding or skipping clock cycles derived from the oscillation frequency. A trim frequency resolution of an LSB of the DTR bits can be more than a maximum trim frequency adjustment provided by the ATR bits. The chip can be operated at an average current of $<1 \mu\text{A}$ and an average power of $<5 \mu\text{W}$. The frequency correcting can comprise continuous non-overlapping frequency adjustment over a range of at least 100 ppm, such as from -63 to 223 ppm.

BRIEF DESCRIPTION OF THE DRAWINGS

A fuller understanding of the present invention and the features and benefits thereof will be accomplished upon review of the following detailed description together with the accompanying drawings, in which:

First, Applicants provide some notation used in the Figures and the detailed description: a capacitor array controlled digitally by input code vectors (DAC or Capacitor DAC); band gap circuit (BGAP), Proportional To Absolute Temperature circuit (PTAT); analog trimming register (ATR); digital trimming register (DTR), and temperature coefficient (TC).

Moreover, although specific numbers of bits are shown for registers shown in the drawings and described herein, the present invention is not limited to the number of bits shown and described for each register.

FIG. 1 shows typical parabolic temperature drift behavior for quartz crystal oscillators used in RTC applications of the tuning fork type.

FIG. 2(a) shows a Pierce Oscillator, which is preferably the oscillator type used with the present invention, while FIG. 2(b) shows the equivalent circuit schematic for a capacitively loaded crystal oscillator, with equations relating the oscillation frequency to the capacitance.

FIG. 3(a) shows a system level schematic for an RTC according to the present invention, while FIG. 3(b) shows a

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more detailed view of the system shown in FIG. 3(a), showing added exemplary sub-components, registers and bitstreams.

FIG. 4(a) is a schematic of an exemplary temperature sensor for determining the temperature of the crystal, and providing the temperature data in digital form.

FIG. 4(b) shows a block diagram which explains operation of a thermometer decoder. The thermometer decoder logic is shown receiving the 6 ATR bits and generating 39 control lines for controlling the switches associated with the DAC.

FIG. 5(a) is an exemplary schematic for a non-linear segmented Capacitor DAC according to an embodiment of the invention.

FIG. 5(b) shows a detailed view of each of the 12 capacitor DAC segments along with the control signal level to activate each capacitor, where the transistors associated with the respective capacitors shown in FIG. 5(a) which receive the control signals are shown simply as switches.

FIG. 6(a) shows trim load capacitance (CL) and resulting parallel resonance frequency (fp) results as a function of ATR trim code for an exemplary Capacitor DAC demonstrating 1 ppm of frequency shift for each ATR bit. FIG. 6(b) compiles data from FIG. 6(a) which clearly demonstrates a linear plot of the resulting fp vs. ATR code. FIG. 6(c) shows continuous non-overlapping ATR/DTR frequency adjustment according to the invention providing adjustment from -63 ppm to 223 ppm.

FIG. 7 shows a RTC system showing a gradual crystal frequency correction scheme in the box CURRENT-ATR inserted into the RTC system shown in FIG. 3(b).

FIG. 8(a) shows an exemplary RTC divider, FIG. 8(b) an exemplary circuitry for implementing a Digital Trimming Process according to the invention, while FIG. 8(c) shows a data simulation demonstrating a gradual and smooth frequency correction using ATR and DTR trimming and the method as described herein.

DETAILED DESCRIPTION

An automatic temperature compensated real time clock (RTC) chip comprises a clock portion including a crystal oscillator block comprising crystal compensation circuitry adapted to be coupled to a crystal, the crystal generally being external to the chip. The compensation circuitry comprises a non-linear capacitor DAC which includes a plurality of load capacitors. The load capacitors have respective switches which switch respective capacitors to change the parallel resonant frequency (fp) provided by the oscillator. The DAC is arranged so that Analog Trimming (ATR) bits received as inputs cause an arrangement of the switches to provide a non-linear change in overall load capacitance, the non-linear change being a parabolic change configured to result in a linear relationship between fp and the number of ATR bits.

An on-chip temperature sensor block is coupled to the crystal for measuring a temperature of the crystal. An A/D converter is coupled to the temperature sensor for outputting a digital signal representative of the temperature of the crystal. A DSP engine receives the digital signal representative of the temperature and calculates the frequency correction needed determines a bit sequence of ATR bits, and optionally DTR bits as described below, to achieve frequency correction. Although the present invention is generally described relative to a quartz crystal which has provides a nominal oscillation frequency of about 32.768 kHz, the present invention can operate with other crystal types which operate at other nominal oscillation frequencies.

RTC chips according to the present invention are very low power, generally drawing a supply current of less than 1 μ a.

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Preferably, the ADC used with the present invention is a low power ADC. For example, the switched-capacitor based ADC disclosed in a paper by Onodera et al. entitled "A Cyclic A/D Converter That does not Require Matched Components", IEEE JNL of Solid-State Circuits, Vol. 23, No. 1, February 1988 can be used. However, other ADC designs may be used with the present invention, preferably being low power designs.

Several other aspects of the present invention significantly contribute to low power aspect of the present invention. The RTC logic described below is preferably run at a low frequency, such as 32.768 kHz. An on-chip voltage regulator is also preferably provided, for example, so that a higher supply voltage received by the chip, such as a VCC of 2.7 to 5.5 volts, is stepped down to a lower voltage, such as 2.4 volts, for use on the RTC chip. Channel lengths of RTC logic gates can also be designed to have comparatively long channel lengths to decrease the magnitude of shoot through currents. The temperature sensor is also preferably designed to have a very low duty cycle. Specifically, in one embodiment, the temperature sensor initiates temperature sampling which lasts around 1 msec, or less, with the sampling occurring for example, only once every minute. The capacitor DAC is also configured to consume essentially no DC power because capacitors do not carry steady DC current. The DTR circuitry which in one embodiment implements the DSP algorithm together with ATR bits is also preferably configured without any hardware multipliers or other power hungry circuitry. The DSP is a lower power module because the DSP algorithm is implemented using hard-wired blocks (as opposed to programmable blocks) which results in much smaller gate count, intermediate signals are bussed, and its speed is optimized for low power application.

FIG. 2(a) shows a Pierce Oscillator which is preferably the oscillator type used with the present invention. Related FIG. 2(b) shows the equivalent circuit schematic for a capacitively loaded crystal oscillator, with equations which relate oscillation frequency to the capacitance. The Pierce Oscillator includes an external crystal oscillator and an associated bias network which includes load capacitors. Although the present invention is described using a Pierce Oscillator, the present invention can use any LC-based oscillator or crystal-based oscillator. Significantly, the parallel resonant frequency, fp, for a Pierce Oscillator, has an inverse square root relationship to load capacitor (C_L) changes.

The invention obtains accurate crystal temperature data on the RTC chip, and uses the temperature data to automatically correct the oscillator frequency as the temperature changes. An on-chip temp sensor, an A/D to digitize the analog sensed temperature data and a DSP algorithm to provide crystal correction based on a stored frequency deflection relationship with temperature for the associated crystal, are preferably all implemented on the same chip, such as a Si chip. As noted above, crystal oscillators use load capacitors to adjust their parallel resonance frequency, fp, and the fp for a Pierce Oscillator has an inverse square root relationship to load capacitor (CL) changes.

The invention uses an on-chip load capacitor array which is controlled digitally by input code vectors. As noted above, such capacitor arrays are referred to herein as Capacitor DACs and inputs to the Capacitor DACs as ATR bits and optionally also DTR bits. Due to the well known nonlinear frequency (fp) to CL relationship provided by a Pierce Oscillator, to achieve a desired linear frequency shift per ATR bit requirement, a non-linear input code can be used. However, as noted in the Background, the generation of a non-linear input code generally requires nonlinear digital signal processing,

which is fairly complex. By instead providing a non-linear capacitor DAC according to the invention, the desired linear frequency shift per ATR bit requirement is provided without the need for a non-linear input code. In a preferred embodiment, the nonlinear capacitor DAC is implemented using a plurality of piecewise linear segments. This frequency control is generally used for automatic crystal frequency compensation against temperature variation. A prototype device was found to provide frequency correction within ± 5 ppm over the full temperature range from -50 to 95° C.

To achieve a linear step size of frequency shift, such as a constant integer number (e.g. 1) ppm of frequency shift for each ATR bit, CL is changed in non-linear parabolic manner. Accordingly, for capacitor DACs according to the present invention, the capacitor DACs are arranged so that ATR bits produce nonlinear parabolic changes in the value of CL, wherein the parabolic change results into linear frequency shifts (see FIG. 6(b) described below). In one embodiment, the shift is a constant integer number/bit, such as a 1 ppm/bit step size.

FIG. 3(a) shows a system level schematic for an RTC system **100** according to the present invention. An on-chip temperature sensor block including a PTAT generator **105** is coupled to the crystal **123** for measuring a temperature of the crystal. ADC **110** is shown as a 10 bit ADC coupled to the PTAT **105** for outputting a digital temperature signal representative of the temperature of the crystal. A DSP engine **115** receives the digital temperature signal. The DSP engine calculates the frequency correction needed to correct for frequency inaccuracy and determines one or more bit sequences to achieve the desired frequency correction. As shown in FIG. 3(a), DSP **115** preferably outputs both ATR bits and another bit sequence referred to herein as digital trimming (DTR) bits to implement the correction. The frequency correction is thus split with the ATR bits being used for fine correction, while the DTR bits are for coarse correction. The DTR bits can also be used to trim the offset of the ADC **110** converter, the gain for ADC **110**, or both the offset and the gain.

As shown in FIG. 3(a), one output of DSP **115** is F_ATR which is 6 bits, with the 6 ATR bits coupled to 6 bit Capacitor DAC **120**, which is coupled to crystal compensation circuit **122**, which is coupled to crystal **123**. Another output from DSP **115** is DTR bits shown as F_DTR. The DTR bits are coupled to digital trim logic **125**. Digital trim logic **125** is shown receiving a 32 kHz signal from crystal compensation circuit **122**, and outputs a 1 Hz signal to RTC **180**. FIG. 3(b) shows a more detailed view of the system shown in FIG. 3(a), showing added exemplary sub-components, registers and bit-streams. In one low power implementation, buck voltage regulator **139** is shown. Buck regulator **139** steps down supply voltage received by the chip to a lower level and provides the stepped down supply voltage to the various circuitry on the chip.

In a preferred embodiment, a six bit ATR output by DSP **115**, ATR<5:0>, changes the on-chip CL for the crystal to change its center frequency in a constant fine resolution of 1 ppm/code. Thus, the six bit ATR can change crystal frequency over ± 32 ppm range in 1 ppm steps. In one embodiment, the DTR is 3 bits, DTR<2:0> which change the crystal frequency digitally by adding or swallowing some clock pulses, such as every second. As described below, DTR is a relatively coarse control with an exemplary range of -32 ppm to $+192$ ppm, with 32 ppm step size.

The ATR bits are applied to a non-linear Capacitor DAC according to the invention **120**. Capacitor DAC **120** is coupled to the crystal compensation circuitry **122** which is coupled to the crystal **123**. The DTR bits are applied to digital

trim logic **125** including a clock divider chain for generating a 1 Hz clock, wherein the DTR bits are coupled to an input the digital trimming module, the digital trimming module performing frequency adjustment on a 1 Hz clock derived from fp as described in more detail below.

FIG. 4(a) is a schematic of an exemplary temperature sensor **400** for determining the temperature of the crystal, and providing the temperature data in digital form. A band-gap reference **410** is shown coupled to PTAT **415** which is coupled to the ADC **420**, shown as a 10 bit ADC. The ADC offset and gain deviations from ideal values are corrected by Process Trim (PTR) bits in the PTAT Generator block **415** as explained below.

PTR(7:0) bits are input to PTAT **415**. ADC **420** has inputs Vptat and Vref. The 10 bit ADC **420** output is given by $1024 * V_{ptat} / V_{ref}$. The Vptat signal ideally should be proportional to Temperature with no DC offset, such that:

$$V_{ptat}(\text{ideal}) = \text{Ideal_Gain_Constant} * \text{Temperature}$$

However, the actual (non-ideal) Vptat signal is as follows:

$$V_{ptat}(\text{actual}) = \text{Gain} * \text{Temperature} + \text{Offset}$$

Thus, PTR(7:0) bits can be used in the present invention to add/subtract dc signals from Vptat (actual) to null out "Offset" voltage as well as correct the "Gain" coefficient to "Ideal_Gain_Constant" value. After Offset and Gain corrections, ADC **420** advances by 2 LSB for each 1 deg C. or:

$$\text{ADC}(\text{Code in Decimal}) = 2 * (\text{Temperature} + 273)$$

PTR bits can be set by the test program thru a Serial Interface to the RTC chip. In one arrangement, the test program checks ADC codes at 2 different known temperatures and calculates Gain and Offset trim bit values. These PTR(7:0) bits can then be stored permanently inside the chip using a non volatile memory, such as an EE memory register.

FIG. 4(b) shows a block diagram which explains operation of a thermometer decoder **450**. The thermometer decoder **450** is shown receiving the 6 ATR bits and generating 39 control lines for controlling the respective switches associated with the Capacitor DAC according to the present invention.

FIG. 5(a) is an exemplary schematic for a non-linear segmented Capacitor DAC according to an embodiment of the invention showing connection to a <38:0> control signal. FIG. 5(b) shows a detailed view of each of the 12 capacitor DAC segments along with the control signal level to activate each capacitor, where the transistors associated with the respective capacitors shown in FIG. 5(a) which receive the control signals are shown in simplified functional form as switches. The <38:0> control signal can be provided by the thermometer decoder shown in FIG. 4(b). Unlike conventional Capacitor DACS, the capacitor DAC segments shown in FIG. 5(b) are not binary weighted relative to one another. Note also that some DAC segments have three (3) associated capacitors (segments **1** and **6-12**), while some segments have four (4) associated capacitors (segments **2-4**).

FIG. 6(a) shows trim load capacitance (CL) and resulting parallel resonance frequency (fp in Hz) results as a function of ATR trim code for an exemplary Capacitor DAC according to the present invention demonstrating 1 ppm (1 ppm=0.037 Hz) of frequency shift for each ATR bit. Significantly, the delta CL for the Capacitor DAC is non-linear with respect to ATR bits, with the non-linearity being parabolic in nature and shaped to replicate the fp to CL relationship of the crystal. The result is a constant 1 ppm of frequency shift for each ATR bit. FIG. 6(b) compiles data from FIG. 6(a) which clearly demonstrates a linear plot of the resulting fp (y-axis) vs. ATR code (x-axis).

A simplified flow chart for the present invention can be described as follows: The user measures F_{out} provided by a pin on the RTC chip at room temperature and inputs **ATR0**, **DTR0** for initial accuracy, or to compensate for crystal aging. On the circuit, the following data sequence automatically occurs:

band gap (BGAP) Ref+PTAT → 10 bit ADC → Junction Temp (e.g. in Kelvin) → crystal TC LOGIC → F_{ATR} and F_{DTR} → NonLinear DACs of crystal Oscillator → temperature compensated fp.

Another inventive aspect of the present invention relates to a new frequency trim algorithm and implementing circuitry. As noted in the background, a typical stability of a crystal can be described by equation (1), repeated below.

$$\Delta f = \Delta f_r + \alpha(T - T_{25})^2 \quad (1)$$

In order to compensate the initial frequency error Δf_r , the present invention can use initial trim registers, such as an Initial Digital Trimming Register (**DTR0**) and the Initial Analog Trimming Register (**ATR0**). The user can measure F_{out} provided by a pin on the RTC chip at room temperature and input **ATR0**, **DTR0** which corrects for initial accuracy, or sometime later to compensate for crystal aging. These two registers are used to program the initial frequency correction term IPPM.

As noted above, the trimming preferably splits the frequency correction into two portions, referred to herein as **ATRs** and **DTRs**, the coarser **DTRs** minimizing the chip area needed for phase adjustment on the crystal. Digital trimming which is based on adding or swallowing (omitting) some pulses from the crystal compensation circuitry is a technique that has been applied to previous generations of RTC chips. However, the combination of **ATR** and **DTR** according to the present invention which provides continuous, non-overlapping frequency adjustment was unknown prior to the present invention. For example, FIG. 6(c) shows continuous non-overlapping **ATR/DTR** frequency adjustment according to the invention providing adjustment from -63 ppm to 223 ppm. The continuous gradual non-overlapping frequency adjustment shown minimizes the disturbance that occur on the crystal and the rest of the clock system on the RTC chip using known correction schemes.

As described above, the initial Digital Trimming Register (**DTR0**) and Initial Analog Trimming Register (**ATR0**) can be used to program the initial frequency correction term IPPM. The frequency correction (in ppm) corresponding to these registers are shown on Table 1 and Table 2 below.

TABLE 1

Initial Exemplary Digital Trimming Register and corresponding frequency correction	
DTR0	PPM
00	0 ppm
01	+32 ppm
10	0 ppm
11	-32 ppm

TABLE 2

Initial Exemplary Analog Trimming Register and corresponding frequency correction	
ATR0 CODE	PPM
000000	32
000001	31
000010	30
000011	29
000100	28
000101	27
000110	26
000111	25
001000	24
001001	23
001010	22
001011	21
001100	20
001101	19
001110	18
001111	17
010000	16
010001	15
010010	14
010011	13
010100	12
010101	11
010110	10
010111	9
011000	8
011001	7
011010	6
011011	5
011100	4
011101	3
011110	2
011111	1
100000	0
100001	-1
100010	-2
100011	-3
100100	-4
100101	-5
100110	-6
100111	-7
101000	-8
101001	-9
101010	-10
101011	-11
101100	-12
101101	-13
101110	-14
101111	-15
110000	-16
110001	-17
110010	-18
110011	-19
110100	-20
110101	-21
110110	-22
110111	-23
111000	-24
111001	-25
111010	-26
111011	-27
111100	-28
111101	-29
111110	-30
111111	-31

Also as described above, referring again to FIG. 3(b), the PTAT generator and exemplary 10 bit ADC can be used to build a temperature sensor, which gives the measurement of the temperature on the RTC chip. 9 MSB bits can be used to represent the temperature in Kelvin. This ADC output is then preferably clamped and converted into Celsius (TEMPC), within the temperature range from -50° C. to 95° C.

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To convert the parabolic curvature constant α into binary code, a 7 bit register (ALPHA) can be used, where

$$\text{ALPHA} = \alpha \cdot 1024 \quad (2)$$

The ALPHA register can be in the value of 33 hex.

The DSP will then compute the product term PROD and temperature/crystal dependent correction term CPPM, where

$$\text{PROD} = \text{ALPHA} \cdot (T - T_{25})^2 \quad (3)$$

and

$$\text{CPPM} = \frac{\text{ALPHA} \cdot (T - T_{25})^2}{1024} \quad (4)$$

The final frequency correction needed, the Net PPM (NPPM), is then given by

$$\text{NPPM} = \text{IPPM} + \text{CPPM} \quad (5)$$

The NPPM is an 11 bit register, and it is in the structure as shown below,

$$\text{NPPM} = [\text{S}, \text{X1}, \text{X0}, \text{D2}, \text{D1}, \text{D0}, \text{A4}, \text{A3}, \text{A2}, \text{A1}, \text{A1}] \quad (6)$$

Where:

S=Sign Bit; Indicates the direction of correction

[X1,X0]=Extra Bits; If either one of them is at Logic High (1), it means that the Net PPM desired has been outside the correction limit, which in the embodiment described herein is within -63 ppm to +223 ppm.

Because of the above-described NPPM structure, the NPPM bits can be simply distributed into Final Digital Trimming Register (F_DTR) and Final Analog Trimming Register (F_ATR), respectively. FIG. 7 shows a RTC system showing a gradual crystal frequency correction scheme in the box CURRENT_ATR 143 inserted into the RTC system shown in FIG. 3(b). As seen in FIG. 7, the crystal compensation circuit output (F32 kHz clock), is the clock fed into the divider chain (within the digital trim logic) to generate the 1 Hz signal for the RTC application.

Regarding analog trimming and CURRENT_ATR 143, the F_ATR is the final input that is applied to the 6 bit capacitor DAC, which modulates the oscillating frequency of the crystal. For a 6 bit F_ATR trimming 1 ppm/bit, the F_ATR provides frequency trimming between the ranges of ± 32 ppm, as shown in Table 2 above.

In order to minimize the disturbance on the crystal and crystal compensation circuit, in a preferred embodiment of the invention the CURRENT_ATR is directly connected to the DAC. Once the F_ATR has been computed, the CURRENT_ATR will move toward the F_ATR gradually, such as with one ppm per crystal clock, until CURRENT_ATR is equal to the F_ATR. In the extreme case, it takes 64 crystal clocks to complete such adjustment. This new technique provided smooth phase modulation for the crystal and avoids overshoot.

Regarding digital trimming for RTC, as described above, the crystal can suffer from frequency fluctuation of up to 200 ppm over the operating temperature range. However, it is extremely costly in terms of chip area to correct such a wide frequency variation by using conventional ATR trimming. In a preferred embodiment, ATR trimming is preferably limited among the frequency correction of ± 32 ppm, while the rest of the correction, up to the range of 192 ppm, is implemented by utilizing the DTR function. The effect of exemplary F_DTR trimming is shown in Table 3 below.

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TABLE 3

Exemplary F_DTR and corresponding frequency correction	
F_DTR	PPM
000	0 ppm
001	+32 ppm
010	+64 ppm
011	+96 ppm
100	+128 ppm
101	+160 ppm
110	+192 ppm
111	-32 ppm

Since the RTC ticks on the 1 Hz frequency, the RTC includes a divider chain to generate the 1 Hz clock, with an exemplary frequency divider 800 being shown in FIG. 8(a). Frequency divider 800 includes fifteen D flip-flops 801 to 815 coupled in series to divide down the 32 kHz input to 1 Hz by dividing by 2 fifteen times ($2^{15}=32,768$).

DTR correction is frequency correction that is applied to clock F1Hz circuitry. To speed up the F1Hz, the circuit should count faster in the divider chain by counting a single F32 kHz cycle twice. While to slow down the F1Hz, the circuit should skip a count of an F32 kHz cycle. This is implemented according to an embodiment of the invention as shown as DTR circuitry 840 in FIG. 8(b) by replacing the first two flip-flops of the divider chain shown in FIG. 8(a) by a programmable counter 850, which count among 3, 4 or 5, depending on the F_DTR registers. The programmable counter generates the new F8 kHz clock and feeds it into the rest of the divider chain 860. a 5208 counter 855 is interfaced with divider chain 860 and programmable counter 850.

Again, to achieve smooth frequency adjustment, and also to achieve a large correction range, such as up to 192 ppm, the frequency trimming adjustment is performed gradually by distributing the trim among the 1 million cycles of F32 kHz. This means that every 5208 (1 million/192) cycles of F32 kHz clock, a trimming will happen, depending on the input of F_DTR. This is depicted in FIG. 8(b).

As an example, FIG. 8(c) shows a smooth correction provided by the invention for a case where the F_ATR gives a correction of +30 ppm; and F_DTR gives the correction of +32 ppm. After finishing the computing of F_ATR and F_DTR, the DSP moves the CURRENT_ATR in every crystal clock until the CURRENT_ATR reach the desired F_ATR value of +30 ppm. Then the DSP fine tunes the divider chain every 5,208 crystal clocks to accomplish the rest of the correction.

Although the present invention is described herein applied to an RTC circuit, the invention can be used in a variety of other products, including clock synthesizers, phase lock loops, crystal oscillators, and other timing products. The low power aspect of the present invention, generally requiring no more than 1 μ a at 2.4 volts for implementation as an RTC, for example, makes the present invention highly desirable for many applications because of the ability to limit the battery backup power supply required.

In the preceding description, certain details are set forth in conjunction with the described embodiment of the present invention to provide a sufficient understanding of the invention. One skilled in the art will appreciate, however, that the invention may be practiced without these particular details. Furthermore, one skilled in the art will appreciate that the example embodiments described above do not limit the scope of the present invention and will also understand that various modifications, equivalents, and combinations of the disclosed

embodiments and components of such embodiments are within the scope of the present invention.

Moreover, embodiments including fewer than all the components of any of the respective described embodiments may also within the scope of the present invention although not expressly described in detail. Finally, the operation of well known components and/or processes has not been shown or described in detail below to avoid unnecessarily obscuring the present invention.

One skilled in the art will understand that even though various embodiments and advantages of the present Invention have been set forth in the foregoing description, the above disclosure is illustrative only, and changes may be made in detail, and yet remain within the broad principles of the invention. For example, some of the components described above may be implemented using either digital or analog circuitry, or a combination of both, and also, where appropriate may be realized through software executing on suitable processing circuitry. The present invention is to be limited only by the appended claims.

It is to be understood that while the invention has been described in conjunction with the preferred specific embodiments thereof, that the foregoing description as well any examples provided are intended to illustrate and not limit the scope of the invention. Other aspects, advantages and modifications within the scope of the invention will be apparent to those skilled in the art to which the invention pertains.

The Abstract of the Disclosure is provided to comply with 37 C.F.R. §1.72(b), requiring an abstract that will allow the reader to quickly ascertain the nature of the technical disclosure. It is submitted with the understanding that it will not be used to interpret or limit the scope or meaning of the claims.

We claim:

1. An automatic temperature compensated real-time clock (RTC) chip, comprising:

a clock portion including a crystal oscillator block comprising crystal compensation circuitry adapted to be coupled to a crystal, said crystal compensation circuitry comprising a non-linear capacitor DAC including a plurality of load capacitors, said load capacitors having respective switches which switch respective ones of said load capacitors to change a parallel resonance frequency (fp) generated by said oscillator block, wherein said capacitor DAC is arranged so that Analog Trimming (ATR) bits received cause an arrangement of said switches to provide a non-linear change in overall load capacitance to result in a linear relationship between said fp and said ATR bits;

a temperature sensor block coupled to said crystal for measuring a temperature of at least said crystal;

an A/D converter coupled to said temperature sensor for outputting a digital temperature signal representative of said temperature of said crystal, and

a DSP engine for receiving said digital temperature signal, said DSP engine calculating frequency correction needed to correct for frequency inaccuracy and determining a bit sequence comprising said ATR bits to achieve said frequency correction.

2. The RTC of claim **1**, wherein said non-linear DAC comprises a piecewise linear segmented DAC, comprising a plurality of piecewise linear segments connected in parallel.

3. The RTC of claim **2**, wherein said plurality of segments are binary weighted segments.

4. The RTC of claim **2**, wherein some of said plurality of segments are controlled by a first number of said ATR bits and other of said plurality of segments are controlled by a different number of said ATR bits.

5. The RTC of claim **1**, further comprising thermometer decoder logic for receiving said ATR bits and generating a plurality of control lines for controlling said switches.

6. The RTC of claim **1**, wherein said DSP calculation splits said frequency correction into said ATR bits and into coarser Digital Trimming (DTR) bits, wherein said digital trimming bits are operable to perform frequency correction by adding or skipping clock cycles.

7. The RTC of claim **6**, further comprising a RTC digital trimming module including a clock divider chain for generating a 1 Hz clock from said fp, wherein said DTR bits are coupled to an input of said digital trimming module, wherein said digital trimming module performs said frequency adjustment on said 1 Hz clock.

8. The RTC of claim **1**, wherein said temperature sensor block comprises a delta Vbe-based temperature sensor.

9. The RTC of claim **8**, wherein said temperature sensor block further comprises a PTAT block coupled between said Vbe-based temperature sensor and said A/D converter, wherein process trim (PTR) bits coupled to said PTAT trim at least one of offset and gain for said A/D converter.

10. The RTC of claim **1**, wherein said chip runs at an average current of $<1 \mu\text{A}$ and an average power of $<5 \mu\text{W}$.

11. The RTC of claim **10**, further comprising a buck voltage regulator on said chip for stepping down a supply voltage received by said chip to a lower level.

12. The RTC of claim **1**, wherein said temperature sensor block operates with a duty cycle of $<1:1,000$.

13. The RTC of claim **7**, wherein said DSP engine is configured exclusive of hardware multipliers.

14. The RTC of claim **7**, wherein said A/D converter is a switched-capacitor based A/D converter.

15. A method for temperature compensating a real time clock (RTC) circuit, comprising the steps of:

providing a real-time clock (RTC) having a crystal oscillator block comprising a crystal coupled to crystal compensation circuitry, said crystal compensation circuitry comprising a non-linear Capacitor DAC having a plurality of load capacitors having respective switches which switch respective ones of said load capacitors to change a parallel resonance frequency (fp) generated by said oscillator block, wherein said capacitor DAC is arranged so that Analog Trimming (ATR) bits received cause an arrangement of said switches to provide a non-linear change in overall load capacitance resulting in a linear relationship between said fp and said ATR bits; measuring a temperature of said crystal; generating an input code comprising said ATR bits based on said temperature to correct said fp, and frequency correcting by applying said input code as said input code vectors to said Capacitor DAC to provide a frequency shift to temperature correct an oscillator frequency of said crystal oscillator.

16. The method of claim **15**, wherein said linear relationship comprises a constant integer/bit.

17. The method of claim **15**, wherein said generating comprises generating Digital Trimming (DTR) in addition to said ATR bits, wherein said DTR bits provide a coarser frequency adjustment as compared to said ATR bits and are operable by adding or skipping clock cycles derived from said oscillation frequency.

18. The method of claim **17**, wherein a trim frequency resolution of an LSB of said DTR bits is more than a maximum trim frequency adjustment provided by said ATR bits.

19. The method of claim **15**, wherein said RTC runs at an average current of $<1 \mu\text{A}$ and an average power of $<5 \mu\text{W}$.

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20. The method of claim 15, wherein said frequency correcting comprises continuous non-overlapping frequency adjustment over a range of at least 100 ppm.

21. *An automatic temperature compensated real-time clock (RTC) chip, comprising:*

a clock portion including a crystal oscillator block comprising crystal compensation circuitry adapted to be coupled to a crystal, said crystal compensation circuitry comprising a non-linear capacitor DAC, wherein said non-linear capacitor DAC is arranged so that Analog Trimming (ATR) bits received cause a non-linear change in overall load capacitance to result in a linear relationship between said ATR bits and a parallel resonance frequency (fp) generated by said oscillator block;

a temperature sensor block coupled to said crystal for measuring a temperature of at least said crystal;

an A/D converter coupled to said temperature sensor for outputting a digital temperature signal representative of said temperature of said crystal, and

a DSP engine for receiving said digital temperature signal, said DSP engine calculating frequency correction needed to correct for frequency inaccuracy and determining a bit sequence comprising said ATR bits to achieve said frequency correction.

22. *A method for temperature compensating a real time clock (RTC) circuit, the method comprising:*

measuring a temperature of a crystal oscillator block;

generating an input code comprising Analog Trimming (ATR) bits based on said temperature to correct a parallel resonance frequency (fp) generated by said oscillator block, and

applying said input code as input code vectors to a capacitor DAC to provide a frequency shift to temperature correct an oscillator frequency of said crystal oscillator, wherein said capacitor DAC is arranged so that said ATR bits received cause a non-linear change in overall load capacitance resulting in a linear relationship between said fp and said ATR bits.

23. *The RTC chip of claim 21, wherein the bit sequence further comprises Digital Trimming (DTR) bits for coarser frequency correction than the ATR bits.*

24. *The RTC chip of claim 21, further comprising at least an initial trim register for compensating for an initial frequency error of the crystal.*

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25. *The RTC chip of claim 21, wherein the crystal compensation circuitry digitally trims the parallel resonance frequency by adding or omitting pulses from the clock signal using Digital Trimming (DTR) bits in conjunction with using the bit sequence comprising ATR bits in a continuous and non-overlapping manner.*

26. *The RTC chip of claim 21, wherein the non-linear capacitor DAC comprises a plurality of piecewise linear segments connected in parallel.*

27. *The RTC chip of claim 21, wherein the RTC chip is coupled to a computing device, wherein the corrected fp is used to control a calendar of the computing device.*

28. *The RTC chip of claim 21, wherein each ATR bit corresponds to a 1 ppm frequency shift of the fp.*

29. *The RTC chip of claim 21, wherein the DSP engine calculating frequency correction is based on a stored relationship of frequency deflection with temperature for the crystal.*

30. *The method of claim 22, wherein generating an input code further comprises generating Digital Trimming (DTR) bits to correct the parallel resonance frequency, wherein each DTR bit provides a coarser correction to the parallel resonance frequency than an ATR bit.*

31. *The method of claim 22, further comprising adjusting a calendar of a computing device coupled to the RTC circuit based on the input code.*

32. *The method of claim 22, wherein generating an input code further comprises using a relationship of frequency deflection with temperature for the crystal oscillator.*

33. *The method of claim 22, further comprising compensating for an initial frequency error of the crystal oscillator by storing an initial ATR or Digital Trimming (DTR) bit in at least an initial trim register for compensating for an initial frequency error of the crystal oscillator.*

34. *The method of claim 33, wherein storing the initial ATR or DTR bit comprises adjusting to correct for aging of the crystal oscillator.*

35. *The method of claim 34, further comprising: providing the temperature corrected oscillator frequency to one of a network device, clock synthesizer, phase lock loop, computing device, or electronic device coupled to the RTC circuit.*

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